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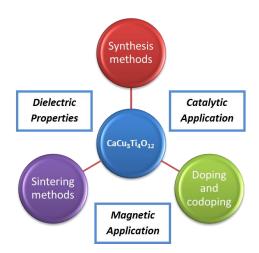
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# From synthesis to applications: Copper calcium titanate (CCTO) with outstanding properties

Sara Kawrani <sup>a,b</sup>, Madona Boulos <sup>b</sup>, David Cornu <sup>a</sup>, Mikhael Bechelany <sup>a\*</sup>

**Table of contents entry**: In this review, the synthesis and the sintering approaches, the dopant elements used as well as the applications of Copper calcium titanate (CCTO) will be reported. In addition to the dielectrical properties useful to energy storage devices; CCTO could serve as magnetic materials as well as photo- and photoelectro-catalytic materials with a very good performance in visible light.



### **Abstract**

Investigations focusing on electrical energy storage capacitors especially the dielectric ceramic capacitors for high energy storage density are attracting more and more attention in the recent years. Ceramic capacitors possess a faster charge-discharge rate and improved mechanical and thermal properties compared with other energy storage devices such as batteries. The challenge is to obtain ceramic capacitors with outstanding mechanical, thermal and storage properties over large temperature and frequencies ranges.  $ABO_3$  as a type of perovskites showed a strong piezoelectric, dielectric, pyroelectric, and electro-optic properties useful as energy storage and environmental devices.  $CaCu_3Ti_4O_{12}$  (CCTO) perovskite with cubic lattice (Im3 symmetry) was discovered to have a colossal

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dielectric constant ( $10^4$ ) that is stable over a wide range of frequencies (10Hz-1MHz) and temperature independence (100-300K). The origin of this high dielectric constant is not fully established, specially because it is the same for single crystal and thin films. In this review, the history of CCTO will be introduced. The synthesis and the sintering approaches, the dopant elements used as well as the applications of CCTO will be reported. In addition to dielectrical properties useful to energy storage devices; CCTO could serve as photocatalytic materials with a very good performance in visible light.

### **Introduction:**

Ferroelectric materials consist of domains with a spontaneous polarization in the absence of an external electric field, and in which this polarization is reversible under the application of an electric field of magnitude less than the dielectric breakdown of the material itself. Spontaneous polarization is the value of charge per unit area on the surface perpendicular to the axis of spontaneous polarization[1]. The magnitude of the net spontaneous polarization possessed by a ferroelectric material starts to decrease while increasing the temperature or the pressure. A phase transition from ferroelectric state to a non-polar paraelectric state took place above a critical temperature  $T_c$  (and a critical pressure  $P_c$ ), called the Curie temperature in which the spontaneous polarization disappears. The structural phase transition from paraelectric to ferroelectric phase is due to the displacement of both cations occupying the A and B sites in the perovskite. This transition may cause a change in dielectric, thermal and other properties of the material.

Ferroelectric materials are divided into four groups; one of these groups is the perovskite. A perovskite is a material with the same crystal structure as calcium titanium oxide (CaTiO<sub>3</sub>). Perovskites have the general formula ABO<sub>3</sub>, where A and B are metal cations (ion radius of A is larger than that of B). An ideal structure is cubic with space group symmetry Pm3m, and it is the simplest example of a structure containing two different cations. Due to the relative sizes of the A and B cations, three types of distortions appear in the simple cubic perovskite structure:

- Distortions of the octahedral units (Jahn-Teller distortion)

- B-cation displacements within the octahedral leading to either a ferroelectric (if all the B atoms move in the same direction) or antiferroelectric (if the B atoms move in opposite directions) structure.
- The relative titling of one octahedral to another. The size of the unit cell increase while reducing the A-site size and no changes in the B-cation environment in such titling [2]. Goldschmidt examined the octahedral titling disordered [3]. In order to determine the stability of perovskite phases, he was based on a formula to define the tolerance factor t in the following equation:

$$t = (R_A + R_B) / \sqrt{2} (R_B + R_X) \tag{1}$$

Where  $R_A$ ,  $R_B$  and  $R_X$  are the ion radii of the A-site and B-site cations and the X-site anion respectively in an  $ABX_3$  perovskite. The average ionic radius of the ions occupying each site is considered in cases of complex perovskites. The deviation of t values indicates the degree of distortion of a perovskite from the ideal cubic structure.

Barium titanate is a model of ferroelectric materials and belongs to the perovskite group with high dielectric properties. It has been seen that even the crystal structure of calcium titanate  $(CaTiO_3)$  and barium titanate  $BaTiO_3$  is not truly cubic, it is slightly modified [4]. The crystalline phases of barium titanate varied at different temperatures. It is paraelectric at high temperature with a cubic phase, tetragonal and [100] polarized below its Curie temperature  $(T_c=120^{\circ}C)$ , orthorhombic and [110] polarized below 5°C, and rhombohedral and [111] polarized below -90°C.

For the miniaturization of electronic devices, high dielectric constant materials are highly useful. Barium titanate and Lead titanate (PbTiO<sub>3</sub>) perovskites were used widely; they showed different crystalline phases at different temperatures which leads to dielectric properties variation. In addition to that, both BaTiO<sub>3</sub> and PbTiO<sub>3</sub> showed important dielectric properties useful for capacitor application, but they contain materials which are severally toxic for human body and therefore are non-environment friendly materials [5], so searching a perovkite with stable properties is important to such applications.

Many researches have been recently investigated the synthesis and characterization of the pseudo-cubic perovskite  $CaCu_3Ti_4O_{12}$  (commonly called CCTO), because of its unusual electrical properties. The high dielectric constant 1 KHz for this type of oxides was first reported in 2000 by Subramanian *et al.* [6]. Calcium copper titanate was synthetized for the first time using conventional powder-sintering technique. Highly pure starting materials were used (99%) of oxides (CaO, TiO<sub>2</sub> and CuO). The mixed powder was calcined at 900-1000°C for 8h, and then the calcined powder was reground and pressed into disks. The disks were sintered in air at 1000-1200°C [6]. The structure of CCTO (space group Im3) can be derived from an ideal cubic perovskite structure ABO<sub>3</sub> by superimposing a body centered ordering of  $Ca^{2+}$  and  $Cu^{2+}$  that share the A site, and  $Ti^{4+}$  is on B site. Due to the different ionic radius between Cu and Ca atoms, a tilting of  $TiO_6$  octahedral planar appears [7]. This distortion forms a square planar oxide environment convenient to Jahn-Teller distorted  $Cu^{2+}$  [8] (Figure 1).

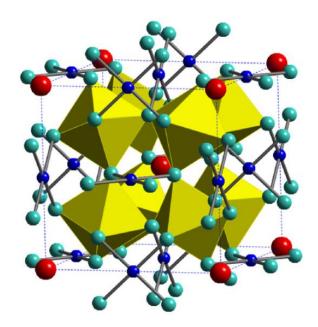


Figure 1: Structure of the cubic pseudo-perovskite (Im3) CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> with TiO<sub>6</sub>, Cu in square planar coordination (small black spheres) about O (small light grey spheres) and Ca at the origin and cube center (medium size grey spheres). Reprinted with permission from (Subramanian et al., 2009). Copyright 2009 Elsevier. [9]

CCTO has been found as a material that shows an outstanding dielectric permittivity (up to 10<sup>4</sup>) at low frequency and stable at a large frequency scale (10<sup>2</sup>Hz-10<sup>6</sup>Hz). It has been noticed that

this giant dielectric permittivity is temperature independent over a wide temperature range between 100 and 600 K [9] which makes this oxide very attractive for technological applications. Despite the high permittivity, CCTO loss tangent still high and constitute an obstacle for commercial applications [10,11]. The origin of this important permittivity is not fully understood and many hypotheses based on intrinsic and extrinsic properties were suggested. Subramanian *et al.* suggested an intrinsic origin for this high permittivity explained by a ferroelectric relaxation that affects the rearrangement of Ti<sup>4+</sup> ions [6], Sinclair *et al.* [7,12–14] showed that the high permittivity is due to an internal barrier layer capacitor and not to an intrinsic feature of the bulk crystal structure. They demonstrated that CCTO ceramics are formed from semiconducting grains separated by insulating grains boundaries and they suggested an electrical model that consists of two parallel capacitance-resistance (RC) elements, R<sub>g</sub>C<sub>g</sub> and R<sub>gb</sub>C<sub>gb</sub> representing semiconducting grains and insulating grains boundaries respectively, both connected in series [7] (Figure 2). It is now fully accepted that the origin of the exceptional electrical properties of CCTO ceramics are due to an internal barrier layer capacitance (IBLC) origin.

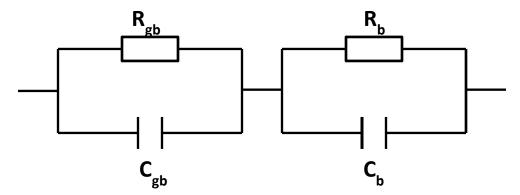


Figure 2: simplified equivalent circuit consisting of two parallel RC elements connected in series. Updated from reference [15]

Basing on the experimental results, it has been possible to use CCTO for fabricating an efficient energy storage device (EDS), and can be used for the evolution of solid state capacitors of class II type. In addition to that, CCTO is a wide gap n-type semiconductor material and can be used for high temperature electronics, basing on studies of the resistivity at high temperature [16].

However decreasing dielectric loss with maintaining a high dielectric constant is the challenge. Many investigations have been done to understand the origin of these dielectric properties and their relation with CCTO crystal structure.

Several reviews focusing on different perovskite materials and their dielectric properties such as barium titanate (BaTiO<sub>3</sub>) [17] and Lead titanate (PbTiO<sub>3</sub>) [18] have been reported recently. In 2016, Ahmadipour *et al.* reported CCTO ceramics and films fabrication, factors influencing its dielectric properties and its sensing applications [19]. In this review, an overview on the influence of experimental conditions such as synthesis method, sintering approaches and doping elements on the structures and dielectric properties of CCTO will be investigated. The new trend in this field (since 2016) will be mainly discussed. This review will focus, in addition to electrical properties, on the photocatalytic and the magnetic applications of CCTO, two interesting properties that have not been reviewed before.

This review is composed from five sections. In first section, the synthesis methods are discussed. The following section will report the sintering approaches and their influence on dielectric properties. In the third part, different doping elements as well as their influence on the morphology and the dielectric properties of CCTO will be discussed. Finally the new properties of CCTO such as magnetic and photocatalytic properties will be reviewed.

# I. Synthesis methods

In this section the synthesis methods used to design calcium copper titanate such as solid state route (solid-solid, mechanosynthesis method), wet chemistry method or soft chemistry (sol-gel, coprecipitation, hydrothermal method), microwave synthesis and combustion synthesis techniques will be reported.

#### I.1 Solid state route

Solid state route is the first method used to prepare oxide. It is a mixing of solid starting materials. Since those solids do not diffuse in each other at room temperature to form the final compound, an additional step of heating at high temperature is necessary. Solid-state route is divided into two groups, solid-solid by mixing manually the powders in an agate mortar and mechanosynthesis method by using a ball mill machine to mix the precursors.

The CCTO, for dielectric applications, is very largely prepared by the "solid-solid" route. This method consists in making an intimate mixture of oxide powders or precursors of oxides (carbonates, hydroxides or nitrates) of calcium, copper and titanium. Subramanian *et al.* [6] used oxides and carbonates precursors which they calcined at 1000°C. Unfortunately in order to obtain at the end a proper, homogeneous and single phase material, several steps of grinding and calcination at high temperature are required. This is the reason why finding new methods that are rapid and environmentally safe was developed later.

The mechanochemical synthetic route (Figure 3) is a simple and rapid method that allows the direct synthesis of the single phase oxides at low temperatures. One of the most important advantages of this technique is that the starting materials can react together by a simple diffusion mechanism at room temperature. The diffusion mechanism is due to the mechanical stress applied on the precursors during the synthesis. In addition the grains size is reduced during this process [20].

The chemical reaction during the solid-solid and a mechanochemical reaction method for the synthesis of CCTO is shown in equation. **2**:

$$CaCO_3 + 3CuO + 4TiO_2 \rightarrow CaCu_3Ti_4O_{12} + CO_2 \uparrow$$
 (2)

Recently mechanical alloying method is used to prepare CCTO by mixing CaCO<sub>3</sub>, TiO<sub>2</sub> and CuO with or without solvent, followed by a calcination step to synthetize single pure phase of CCTO [14,21–23].

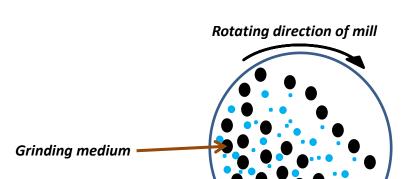


Figure 3: Schematic diagram of a ball mill. Updated from reference [24]

Thirpathy *et al.* [25] mixed a stoichiometric amount of CaCO<sub>3</sub>, TiO<sub>2</sub> and CuO into acetone (as a dispersant agent) using a ball mill in a sealed plastic bottle with zirconium beads. Powders were calcined at different temperatures from 900°C to 1050°C for 10h. Pellets were then sintered at 1100°C for 8h. XRD patterns (Figure.4a) showed that the pure phase of CCTO is given at 1050°C of calcination. As seen in SEM images, (Figure.4b) large grains are surrounded by small ones at the junction for sintered pellets.

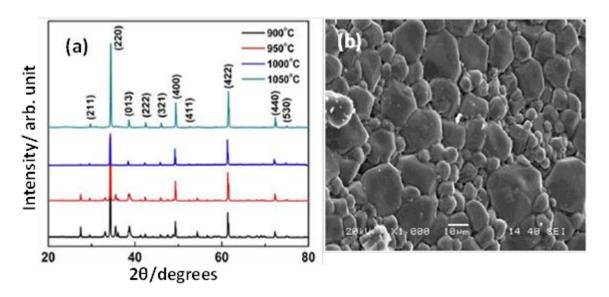


Figure 4: (a) X-ray diffraction patterns of CCTO powder calcined at different temperature and (b) SEM micrograph of CCTO pellet. Reprinted with permission from (triphathy et al. 2016). Copyright 2016 Creative

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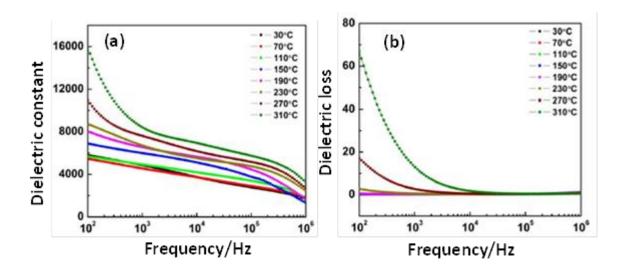


Figure **5**: (a) Frequency dependence of dielectric constant of CCTO pellet at different temperatures and (b) Frequency dependence of dielectric loss of CCTO pellet at different temperatures. Reprinted with permission from (triphathy et al. 2016). Copyright 2016 Creative Commons CC. [25]

Figure 5 (a) showed the frequency dependence of dielectric constant as the function of temperature (30°C-310°C). The permittivity ( $\epsilon$ ') value decreases with increasing the frequency, and at some point,  $\epsilon$ ' increases while increasing temperature. This behavior could be related to the accumulation of charge on interface. Figure 5 (b) showed that the dielectric loss is stable at high frequencies and increases at low frequencies and high temperature, this phenomenon is might due to the increase of conductivity with temperature.

Even if these methods are easy and simple to perform, they suffer from the need of repetitive grinding and the use of a very high temperature for calcination.

#### I.2 Wet synthesis or soft chemistry

Over the past thirty years, new methods improperly called "chemical" have been proposed to develop ceramic oxide powders of higher quality than those obtained by the solid route. Greater purity, better granulometric characteristics and higher reactivity, were reported thus leading to significantly lower sintering temperatures. Among these methods, there are two

main categories: (i) wet synthesis methods under normal atmospheric pressure such as sol-gel and coprecipitation methods and (ii) hydrothermal methods.

#### I.2.1 Sol-gel method

Sol-gel method is one of the well-established synthetic approaches to prepare novel metal oxides nanoparticles. This method has potential control over the textural and surface properties of the materials. Sol–gel method mainly undergoes in few steps to deliver the final metal oxide protocols and those are hydrolysis, condensation, and drying process. The control of kinetics of hydrolysis and condensation of the titanium ions is sought in this type of synthesis. The basic idea is to slow down the formation of Ti-O-Ti sequences to favor the formation of Ti-O-Ca and Ti-O-Cu sequences which prefigure the crystalline structure of calcium cupper titanate instead of TiO<sub>2</sub>. The slowing down of the Ti-O-Ti linkages is caused by a low water supply or by titanium ion fixation of groups such as acetate. The kinetics can also be slowed down by simply lowering the temperature.

The precursors used in this method are metal alkoxide, metal citrate or nitrate. Micrometers particles are distributed by mechanical mixing in a liquid, to form colloidal or sol solution with adjusted pH (Figure 6). Some difficulties are associated with the key steps of this method such as hydrolysis, condensation and drying, which affect directly the morphology of the material.

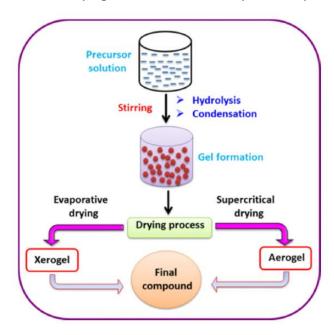


Figure **6**: The Reaction Pathway for the Production of Metal Oxide Nanostructures in the Sol–Gel Method.

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Mao *et al.* [27] have synthesized CCTO using calcium nitrate  $Ca(NO_3)_2.4H_2O$ , copper nitrate  $Cu(NO_3)_2.3H_2O$ , titanium isopropoxide  $(Ti(C_3H_9O)_4)$ , citric acid  $(C_6H_8O_7)$  and ethylene glycol  $(C_2H_6O_2)$  as starting materials. A stoichiometric amount of  $Ca(NO_3)_2.4H_2O$  and  $Cu(NO_3)_2.3H_2O$  were dissolved in ethanol and the pH was adjusted by the addition of citric acid to form solution (A). Solution (B) is formed by mixing  $(Ti(C_3H_9O)_4)$  and ethanol for 1h, then solutions (A) and (B) were mixed together with ethylene glycol at room temperature for 1h to obtain a clean and transparent sol solution. In order to obtain a viscous blue gel, this solution was heated at 90°C in a drying oven, then heated to 120°C and kept for 12h in the drying oven to gain fluffy precursor powders. The precursor powders labeled CCTO from 1 to 6 were calcined at 650°C, 700°C, 750°C, 800°C, 850°C and 900°C for 3h respectively then pressed to form pellets and sintered at 1050°C/10h.

The XRD patterns for the obtained powders and ceramics are shown in (Figure 7). It is clear that CCTO is formed and well crystallized. However traces of CuO and  $TiO_2$  phases are observed in powders calcined at  $900^{\circ}$ C.

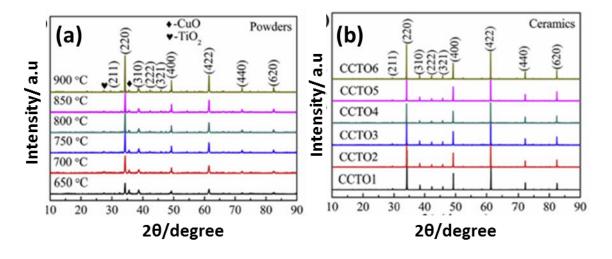


Figure **7**: XRD patterns of the CCTO powders calcined at different temperature (a) and the sintered CCTO ceramics at 1050°C for 10 h (b). Reprinted with permission from (Mao et al.,2019). Copyright 2019 Elsevier [27]

From SEM images they concluded that the grain size distribution depends on the calcination. CCTO labeled 1, 2 and 3 ceramics had homogeneous microstructures, for CCTO labeled from 4 to 6 ceramics large grains are obtained. This could be attributed to the presence of small grains absorbed by large grains. Grain boundaries of CCTO 5-6 ceramics are heterogeneous and large grains are formed.

At low frequency ( $10^2$  Hz) the permittivity and the dielectric loss increase with increasing calcination temperature, and the increasing of the grain size. Thus, the CCTO6 had the highest value for permittivity and  $\tan\delta$ . At medium frequency ( $10^3$ - $10^5$  Hz) it has been observed that CCTO5 exhibit the lowest value of  $\tan\delta$  (0.091).

Compared with the solid route where the homogeneity scale is rarely better than 0.5  $\mu$ m, the sol gel method showed considerable advantages, including excellent chemical stoichiometry, compositional homogeneity, and lower crystallization temperature.

#### I.2.2 Co-precipitation

Co-precipiation is one of the most convenient techniques for the preparation of nanomaterials with a narrow size distribution. The co-precipitation technique does not require costly equipment, stringent reactions or complex procedures. This method is based on mixing stoichiometric amounts of soluble salts of metals to form a precipitate of hydroxides, oxalates, or citrates and then the mixture is filtered, dried and heated to form the final product.

Zhu *et al.* [28] used co- precipitation method to synthetize CCTO powders. They started by dissolving 0.2 mole of oxalic acid in ethanol, the pH of the obtained solution was adjusted to 2.5 - 3 using ammonia. At this point, 0.1 mole of  $Ti(OCH_4H_9)_4$  were added. On the other hand a stoichiometric amount of calcium nitrate (0.025 moles) and copper nitrate (0.075 moles) were dissolved in distilled water. After few minutes, the metal nitrates solution and the oxalic solution were mixed and kept overnight to complete the reaction. The precipitate was filtered,

dried then calcined. Pellets were pressed and sintered by spark plasma sintering at 1000°C for 2h.

Figure 8a shows the XRD patterns of the powders obtained at different calcination temperatures. They confirm the formation of pure CCTO at 700°C calcination temperature.

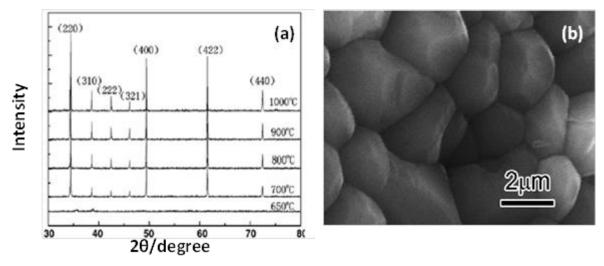


Figure **8**: a) XRD patterns of CCTO calcined in air at various temperature,(b) the SEM photograph of CCTO ceramic bulk. Reprinted with permission from (Zhu et al.,2009). Copyright 2009 Elsevier [28]

SEM image of the obtained ceramic (Figure 8b) showed a dense microstructure with an average grain size between 2 and 5 $\mu$ m. The sintered pellets showed a high dielectric constant > 10<sup>4</sup>, that increases with frequency from 1 KHz to 1MHz due to IBLC model effect.

Using coprecipitation method will help to obtain CCTO at low calcination temperature.

#### I.3 Microwave synthesis

Microwave energy was originally applied for heating food. Recently it has been used to accelerate chemical synthesis. Thus, the microwave energy replaces the calcination step to obtain the pure phase of CCTO powders. The heating effect utilized in microwave assisted synthesis is mainly due to dielectric polarization. This method is based on the emission of a radiation into a solution. If the solution contains charged particles, this particle will move under the influence of a field and produce an oscillating electric current. If the particles in the solution are not charged, the electric field component will cause them to align the dipole moments and

this is the dielectric heating. To use the microwave heating techniques, the compound must contain at least one molecule that can absorb the radiation or must be surrounded by an absorbent molecule to absorb microwave radiations.

Kumar *et al.*[29] used the microwave flash combustion technique to synthetize CCTO, involving microwave irradiation on aqueous solution containing  $Ca(NO_3)_2.4H_2O$ ,  $Cu(NO_3)_2.4H_2O$ ,  $TiO(NO_3)_2$  as an oxidizer and urea  $(CH_4N_2O)$  as a fuel. They prepared an aqueous solution of two precursors  $Ca(NO_3)_2.4H_2O$  and  $Cu(NO_3)_2.4H_2O$  separately, then they mixed these solutions with an stoichiometric amount of urea fuel and oxidizer agent  $(TiO(NO_3)_2)$ . At the end, they obtained a blue gel. This gel is kept in an alumina crucible and put into a microwave costumed oven operating at 2.45 GHz and 1.1KW power. The combustion takes around 30s to be completed. It is accomplished by a flash of light followed by discharge of gaseous mixture  $(O_2, N_2, H_2O)$  and a porous dark-brown residue is obtained. This residue was crushed then calcined at 800°C and 900°C for 5h to obtain CCTO. XRD patterns (figure 9a) showed that the pure phase of CCTO is obtained after calcination at 900°C/5h.

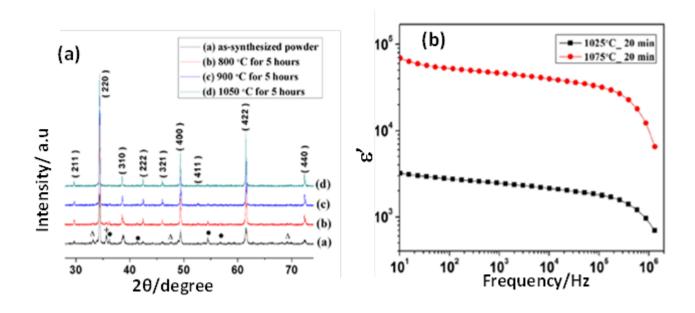


Figure **9**: (a) XRD patterns of CCTO powder samples: (a) as-synthesized, (b) calcinated at 800 °C for 5 h, (c)

calcinated at 900 °C for 5 h, and (d) sintered pellet at 1050 °C for 5 h. The symbols  $\Delta$ , +, and • correspond to the trace of secondary phases CaTiO<sub>3</sub>, CuO, and TiO<sub>2</sub>, respectively, (b) Frequency dependence of the dielectric constant and  $\tan \delta$  of sintered CCTO samples sintered at 1050 °C for 5 h. The inset shows the variation of the real part of the impedance with frequency. Reprinted with permission from ref<sup>[29]</sup>. Copyright © 2015 American Chemical Society

Dielectric properties (Figure 9b) were studied on CCTO pellet (sintered in air with conventional method at 1050°C/5h) and showed that at low frequencies dielectric constant increases, that maybe due to the ceramic-electrode interface effect or to a relaxation dipole at the grain boundaries. However higher dielectric constant and dielectric loss appear at high frequency (0.5-8MHz). This value of dielectric loss is maybe due to that at high frequency just the response of grains is considered and there is charge carriers generated in grains during sintering by reduction of Cu<sup>2+</sup> to Cu<sup>+</sup> and by oxygen loss.

Despite that this approach is very elegant, the final compound cannot be formed after heating into a microwave and a second step of calcination is always needed.

#### I.4 Combustion synthesis technique

By this method, single homogenous nanopowders and single-phase material can be produced; ceramics, catalysis composites alloys and nanomaterials are synthetized and proceeded. A reaction is maintained between a fuel and an oxidant present in the precursor solution. Oxidant are the nitrates of different metals and the fuel generally are citric acid, urea, ethyl glycol or it can be added with some chelating agents such as acetic acid, to form complexes with the metal ions present in the precursor solution. The dehydration of this complex produces a viscous gel, that after self-heating produce a huge quantity of gazes which leads to the formation of pores. The final step is the calcination at high temperature of this gel to have a final product.

Patra *et al.* [30] used an appropriate amount of TiO(NO<sub>3</sub>)<sub>2</sub>, CaCO<sub>3</sub>, CuO, citric acid monohydrate and ammonium nitrate. The pH of the solution was adjusted using NH<sub>4</sub>OH, the solution was kept on a hot plate at 80-90°C. A viscous gel is developed due to the dehydration of the mixed solution during heating. This gel self-ignites resulted from heating is followed by swelling of the gel. A voluminous black precipitate was obtained from this ignition, and then calcined at 800°C

to obtain pure CCTO phase.

Lopera *et al.* [31] used sol-gel method associated with auto-combustion to synthetize Smdoped  $CaCu_3Ti_4O_{12}$ . They used  $(Cu(NO_3)_2)$ ,  $(Ca(NO_3)_2)$  Ti-isopropoxide  $(Ti[OCH(CH_3)_2]_4)$ , Samarium nitrate  $(Sm(NO_3)_2)$ , and acid citric  $(C_6H_8O_7H_2O)$ . In order to have  $Ca_{1-x}Sm_xCu_3Ti_4O_{12}$  (for x=0, x=0.2,x=0.3), starting materials were mixed in distilled water solution then heated on a hot plate magnetic stirrer at 70°C until the auto-combustion is achieved. Precursor powders are sintered at  $1050^{\circ}C/10h$ . XRD patterns (Figure 10) showed that a pure phase of CCTO is formed with almost the same lattice parameter  $7.392\ddot{A}$ ,  $7.394\ddot{A}$  and  $7.395\ddot{A}$  for CCTO (x=0), CCTO2 (x=0.2) and CCTO3(x=0.3) respectively. SEM images showed that grain growth was inhibited after doping by Sm<sup>3+</sup>, and the permittivity at 100 kHz decrease from 15.747 for undoped CCTO to 4126 for CCTO3.

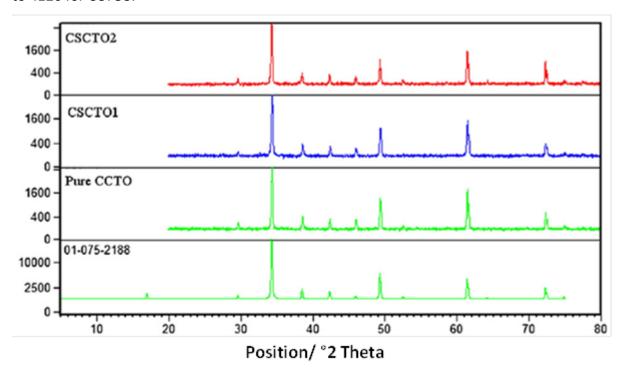


Figure **10**: X-ray diffraction patterns for  $Ca_{1-x}Sm_xCu_3Ti_4O_{12}$  the system CSCTO2 (x = 0.2), CSCTO1 (x = 0.3), and CCTO (x = 0.0). Reprinted with permission from (Lopera et al., 2014). Copyright 2014 Elsevier [31]

Autocombustion method is a rapid process with low-cost and low-temperature. There is a possibility to have multicomponent oxides with single phase and high surface area. It is an exothermic reaction that makes the product almost instantaneously. The disadvantages of this

process are the possibility of contamination with carbonaceous residue and the poor control of morphology.

#### I.5 Hydrothermal method

Hydrothermal method is used in order to synthetize nanosized ceramics. To carry out the reaction under high temperature and pressure, precursors are placed into an autoclave filled with water.

Classically to synthesize CCTO by hydrothermal method [Ti(OC<sub>3</sub>H<sub>7</sub>)<sub>4</sub>], CaCO<sub>3</sub>, Cu(NO<sub>3</sub>)<sub>2</sub>·2.5H<sub>2</sub>O and potassium hydroxide (KOH) are used as starting materials. In deionized water, an appropriate amount of titanium isopropoxide and calcium carbonate was dissolved, the same for copper nitrates, then the two solutions were mixed together with 50 mL from KOH (mineralizer). An amorphous precipitate of Ti(OH)<sub>2</sub>, Ca(OH)<sub>2</sub> and Cu(OH)<sub>2</sub> is formed. In order to avoid the formation of calcium carbonate as second phase, nitrogen gas was constantly bubbled to the system. The mixture is transferred to a Teflon autoclave.

Masigboon *et al.* [32] synthetized  $CaCu_3Ti_4O_{12}$  using the hydrothermal method. In aqueous medium, precursors  $Ca(NO_3)_2.4H_2O$ ,  $Cu(NO_3)_2.3H_2O$ ,  $Ti(OC_3H_7)_4$  and freshly extracted egg white (ovalbumin) were mixed. Egg white protein was used due to his gelling, foaming and emulsifying characteristics. It was no need to pH adjustment with this process. Mixed solutions were treated hydrothermally in autoclave at 150°C and 200°C for 8h. They dry the precursor at 70°C-80°C then it was calcined at 800°C, 900°C and 1000°C/8h.

XRD patterns (Figure **11**) showed that the pure phase of CCTO appears after 800°C of calcination with second phases CaTiO<sub>3</sub>, TiO<sub>2</sub> and CuO. CaTiO<sub>3</sub> appears when there is non-stoichiometric amount of Titanium and calcium. As seen in TEM images (Figure **12**), CCTO had a nanocrystalline structure, in which grain size increases with calcination's temperature. They conclude that with hydrothermal method, CCTO powders can be produced in order to study their dielectric properties.

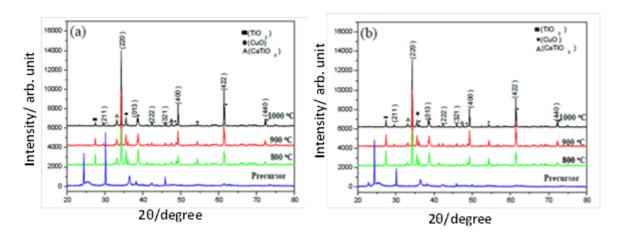


Figure **11**: XRD patterns of CCTO base-powders prepared by hydrothermal process at (a) 150°C/8h and (b) 200°C/8h, respectively. All powders calcined in air for 8 h at 800, 900 and 1000 °C. Reprinted with permission from (Masingboon et al. 2017). Copyright 2017 Creative Commons CC.[32]

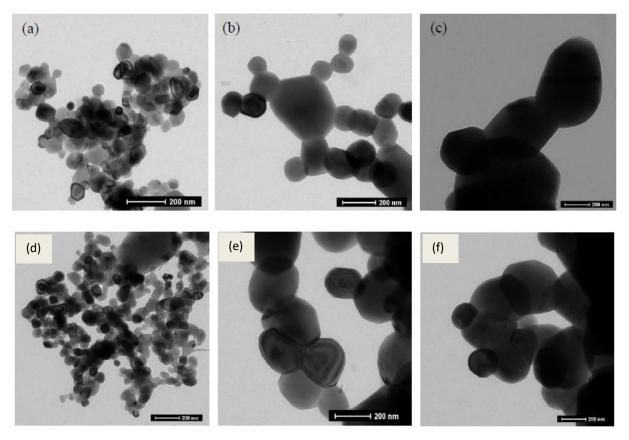


Figure 12: TEM images of CCTO powders, which prepared by hydrothermal process at 150 °C/8h calcined in air for 8 h at (a) 800, (b) 900 and (c) 1000 °C, and at 200 °C/8h calcined in air for 8 h at (d) 800, (e) 900 and (f) 1000 °C, respectively. Reprinted with permission from (Masingboon et al. 2017). Copyright 2017 Creative Commons CC [32]

In order to prepare calcium copper titanate, different synthesis methods are used. The aim of

using these methods (apart solid state route) was to obtain the final compound at lower calcination temperature and with a homogeneous microstructure in order to maintain a high permittivity and a low dielectric loss. In Table 1, some selected examples for these different synthesis methods are showed as well as their influence on permittivity ( $\epsilon$ ') and loss tangent (tan  $\delta$ ). From Table 1, microwave synthesis showed the highest value of dielectric constant ( $\epsilon$ '=53,300) but at the same time the highest dielectric loss ( $\tan\delta$ =0.2), which limit its industrial application. In the next section, the different approaches used for the sintering of CCTO will be reviewed.

Table 1: Resumed comparison between synthesis method and their influence on dielectric properties permittivity  $(\varepsilon')$ , and dielectric loss  $(\tan \delta)$ 

Synthesis Method	Precursors	ε'	$\tan\delta$	References
Solid-solid	CaO,CuO and TiO <sub>2</sub>	10,286	0.067	[6]
Mechanosynthesis	CaCO₃, CuO, TiO₂	~5000	0.14	[21]
Sol-gel	$Ca(NO_3)_2.4H_2O$ , $Cu(NO_3)_2.3H_2O$ ,	3*10 <sup>4</sup>	0.091	[25]
	$Ti(C_3H_9O)_4$ , $C_2H_6O_2$ , $C_6H_8O_7$			
Microwave synthesis	$Ca(NO_3)_2.4H_2O$ , $Cu(NO_3)_2.4H_2O$ ,	53,300	0.2	[27]
	TiO(NO <sub>3</sub> ) <sub>2</sub> , CH <sub>4</sub> N <sub>2</sub> O			
Autocombustion	$Ca(NO_3)_2$ , $Cu(NO_3)_2$ , $Ti[OCH(CH_3)_2]_4$ ,	15,474	-	[29]
	$C_6H_8O_7H_2O$			
Coprecipitation	$H_2C_2O_4.H_2O$ , $Ca(NO_3)_2.4H_2O$ ,	10 <sup>4</sup>	0.09	[26]
	Cu(NO3)2.3H2O, Ti(OC4H9)4			
Modified sol-gel with	$Ca(NO_3)_2.4H_2O$ , $Cu(NO_3)_2.4H_2O$ ,	-	-	[30]
hydrothermal process	TiO(OC₃H <sub>7</sub> )₄			

## II. Sintering and dielectric properties

Sintering (Figure 13) is a well-established process used to consolidate powders by heating green bodies at high temperatures below the melting temperature of the powder. It is a thermal treatment for bonding particles into a coherent, predominantly solid structure via mass transport events that often occur on the atomic scale. The bonding leads to improve strength

and lower system energy. Most industrial sintering is pressure less and performed without any external applied pressure. Pressure assisted sintering techniques include many processes: hot isotactic pressing, hot pressing, flash sintering and Spark Plasma sintering.

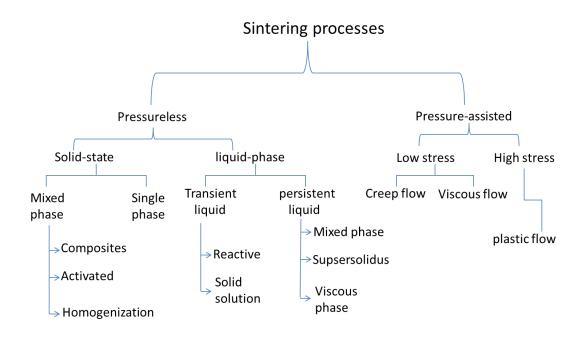


Figure **13**: the taxonomy of sintering, showing process differentiation by various branches, starting with the application of pressure-assisted versus pressureless sintering. Adapted from [33]

There are challenging demands from all the industries involved in nanotechnology for new and improved sintering process with fine microstructure and enhanced mechanical, electrical, optical and physical properties. The aim of modern ceramic technologies is obtaining dense ceramic with nanostructured grains. That is why there are many factors to be optimized during the sintering process, starting from powders (shape and size of grains), green bodies manufacturing (dimensional changing during compacting which is dependent from the pressure) and sintering type and time [34]. In this review, we will present four main methods of sintering used to obtain dense ceramic of CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> such as conventional sintering, microwave sintering, spark plasma sintering and thermobaric treatment.

#### **II.1 Conventional sintering**

The conventional sintering process consists of heating a preformed powder (raw or blended materials) at high temperatures, lower than the melting point, during minutes to hours. The driving force for sintering comes from the high surface energy and curved surface inherent to a powder. There are different "stages" for sintering. A "stage" of sintering can be described as an interval of geometric change in which the pore shape change is totally defined or an interval of time during which the pore remains constant in shape while decreasing in size. The sintering process can be divided into three different stages:

- The initial stage: Sintering initially causes the particles that are in contact to form grain boundaries at the point of contact through diffusion. The neck and grain boundaries are formed during this stage. Neck formation is driven by the energy gradient resulting from the different curvatures of the particles and the neck. Surface diffusion is usually the dominant mass-transport mechanism during the early stages of neck growth, as the compact is heated to the sintering temperature. A smoothing in the surface occurs.
- **The intermediate stage:** During this stage, there is the creation of isolated pore structures. Grain growth and densification occur at this stage too. Densification is assumed to result from pores simply shrinking to reduce their cross section. The intermediate stage normally covers the major part of the sintering process, and it comes to an end when the density of the porous body reaches close to 90 % of the fully dense body.
- **The final stage:** Final stage sintering is much slower than the initial and intermediate stages. During this stage, pore shrinkage and closure happen. Pore shrinkage is one of the most important stages in the sintering process. For this shrinkage to occur, solids must be transported into the pores and the gas present inside the pore must escape to the surface. In the final stage, grain growth occurs.

CCTO was widely prepared by conventional sintering and the electrical properties of the obtained ceramics were extensively studied. Different furnaces types were used to a conventional sintering such as refractory type electrical resistance furnace, induction furnace or fossil fuel furnace. High temperature and long sintering duration are maintained during

sintering process. During heating, the temperature is distributed between elements by the mechanism of conduction, radiation and convection. First the material surface is heated then heat is transferred into material leading to a temperature differences between the surface and inside the material [35].

Sinclair *et al.*[7] prepared the CCTO powders via the mixed oxide route using CaCO<sub>3</sub>, CuO and TiO<sub>2</sub> as starting materials. Pellets were prepared by sintering cold-pressed compacts in air at 1000-1100°C and were 89 to 90% of the theoretical density. The obtained ceramics showed values for permittivity higher than 10 000. The authors explained that the electrical properties of CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> ceramics depend on many variables, including ceramic microstructure (average grain size and pellet density) and processing conditions (oxygen partial pressure, sintering temperature and cooling rate).

Barbier *et al.*[36] prepared CCTO ceramics by adding an organic binder to the powder and the obtained mixture was pressed into pellets of 6 mm in diameter and 1.5 mm thick, at a pressure of 620 MPa. The obtained pellets were sintered in air at 1100°C for 24 h. The density of the samples was approximately 4.8 g cm<sup>-3</sup>. The pellets exhibited a bimodal grain size distribution (Figure 14).

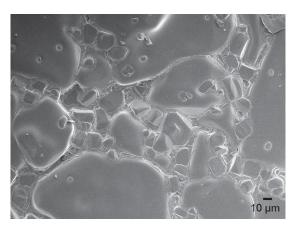


Figure **14**: FEG-SEM micrograph of a 6mm diameter CCTO pellet sintered at 1100 °C for 24 h. Reprinted with permission from (Barbier et al.,2009). Copyright 2009 Elsevier [36]

High values of dielectric permittivity and low losses were observed whatever the electrode ( $\epsilon_r$  =  $1.4 \times 10^5$  and tg  $\delta \sim 0.16$  at 1 kHz). Lukenheimer *et al.* [37] studied the origin of the colossal

dielectric constants of CCTO ceramics prepared by conventional sintering. They performed detailed dielectric measurements on various CCTO samples subjected to different surface and heat treatments. The ceramics were sintered at 1000°C in air for up to 48h. The authors concluded that there must be two different types of insulating layers in CCTO.

Ferrarelli *et al.* [38] undertook impedance spectroscopy study of CCTO single crystals and CCTO ceramics. The authors mentioned that the impedance spectroscopy is a useful technique to characterize electrically heterogeneous materials and can, in many circumstances, be used to identify and separate intrinsic (e.g. bulk) and extrinsic (e.g. grain boundary, non-ohmic electrode contact) effects. The CCTO ceramics were prepared by uniaxially cold pressing of the CCTO powder into 5 mm compacts under an applied pressure of 50 MPa, followed by pressing at 200 MPa in a Flow Autoclave System model 32330 cold isotactic press. Resulting green body compacts were placed on Pt foil and sintered at 1100 °C for 6 h. Heating and cooling rates of 5°C.min<sup>-1</sup> were used for both the powder production and for sintering pellets. CCTO ceramics with a theoretical density of 96 % were obtained. The authors observed a predominantly grain boundary effect (IBLC) for ceramics and an extrinsic electrode – sample interface effect for single crystals.

Fiorenza *et al.* [39] used the combination of scanning impedance microscopy and conductive atomic force microscopy on single crystals of the perovskite-type oxide CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> (CCTO) in order to provide a local dielectric characterization on ingot sections. The authors sintered the single crystals in air for 12h at 1000°C. They demonstrated the presence of insulating inclusions in CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> single crystals, identified to be CaTiO<sub>3</sub>. The CaTiO<sub>3</sub> secondary phase could block/restrict conduction within CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> crystals and could participate in the macroscopic conduction mechanisms.

Schmidt *et al.* [40] synthesized powders of various compositions within the ternary CaO–CuO–TiO<sub>2</sub> phase diagram from different amounts of dried high purity reagents of CaCO<sub>3</sub>, CuO and TiO<sub>2</sub>. For each composition, pellets were pressed from freshly crushed and ground powders using a uniaxial hydraulic press (1 ton) and all were simultaneously sintered at 1100 °C on Pt foil for 12 h. The authors observed an abnormal increase of the CCTO bulk dielectric permittivity in

the absence of CuO secondary phase in the ceramics. Compositions containing CuO phase exhibit increased resistivity.

Turky *et al.* **[41]** demonstrated that without any dopant, only by controlling the chemistry and engineering, the interfacial regions at the grain boundaries, the dielectric loss can be suppressed remarkably while retaining the giant dielectric constant.

Finally, chung et al. [42] prepared pellets sintered in a tube-type furnace at 1100 °C in air for 3 to 20 h and removed immediately to room temperature without any furnace-cooling.

With conventional sintering method, CCTO can be produced in one step of heating, but the use of very high temperature is necessary which is costly in energy domain and non-environmentally.

#### **II.2 Microwave sintering**

Microwave sintering is a newly developed technique used for the sintering of materials that has shown many advantages against the conventional sintering process. Microwaves are a form of electromagnetic radiation with wavelengths ranging from about one meter to one millimeter; with frequencies between 300 MHz and 300 GHz. Originally, microwaves were used for communication. Heating of materials with the use of microwave energy got established in 1950. Thus, the microwave heating gained very fast popularity for processing of ceramics, polymers, metallic based materials and advanced materials.

The processing of material using microwaves depends on its dielectric and magnetic properties as the electric field and the magnetic field of the electromagnetic radiation interact with the material during irradiation. The dielectric interaction of materials with microwaves is characterized by two factors: The absorbed power (P) and the depth of microwave penetration (D). The absorbed power in a material is the dissipated power due to the electric and magnetic fields of microwave energy which could be represented as energy converted inside a heated material. Thus, the power absorbed by a material is significantly influenced by the depth up to which the radiations penetrate into it. However, microwaves cannot penetrate inside in the similar fashion in all materials.

**Transparent** or low dielectric loss materials let the microwaves pass through them without any

loss. **Opaque** or conductive materials reflect the microwaves not allowing them to penetrate. Absorbing or high loss materials where microwaves are absorbed depending on the value of the dielectric loss factor (Figure 15) [35,43].

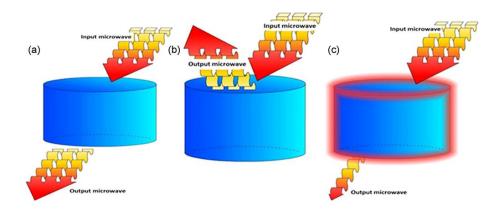


Figure **15**: Three kinds of materials according to the interaction with microwaves: (a) transparent, (b) opaque (conductor) and (c) absorber. Reprinted with permission from (Oghbarir et al., 2010). Copyright 2010 Elsevier [35]

The Basic difference between conventional sintering and the microwave sintering resides in the heating mechanism. (Figure 16) shows the temperature profile for both methods:

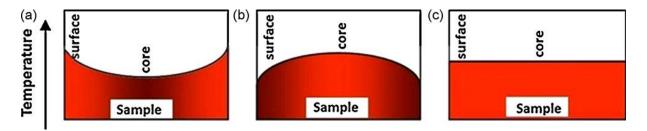


Figure **16**: Temperature profile within the sample in: (a) conventional heating, (b) microwave heating and (c) microwave hybrid heating. Reprinted with permission from (Oghbarir et al., 2010). Copyright 2010 Elsevier [35]

For conventional sintering, heat is generated by heating elements and transferred to samples via radiation, conduction, and convection. In microwave sintering, however, the materials themselves absorb microwave energy, and then transform it into heat within their bodies [35]

The microwave sintering shows many advantages against the conventional sintering process:

- Increased density and more uniform grain sized distribution since it can promote the forward diffusion of ions.
- Lower energy consumption in microwave sintering because the use of microwaves

- facilitates the transfer of energy directly into the materials, providing volumetric heating.
- Reduced sintering time since microwaves directly interact with the particulates within the green pellets rather than being conducted into the specimen from an external heat source, thereby provide rapid volumetric heating [35].

Recently many researchers have been using the microwave sintering process to prepare CCTO ceramics [44,45]. In 2016, Kumar *et al.* [44] demonstrated the effect of microwave heating rate on the sintering of CCTO. The higher is the heating rate (50°C/min) the more uniform and dense is the structure. Conductivity of the obtained ceramics was found to increase with increasing heating rate. They prepared nanocrystalline powders of CCTO by microwave flash combustion technique, the obtained powders were sintered by microwave sintering method. The sintering temperatures were optimized to 1025-1075°C and the duration to 20 minutes. Figure 17 shows the SEM of the obtained ceramics obtained by microwave sintering.

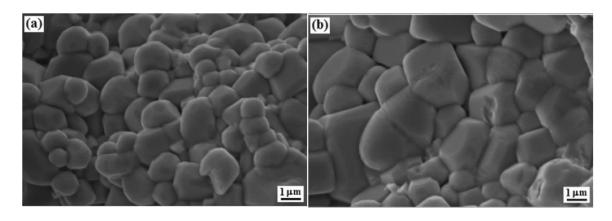


Figure 17: SEM image of CCTO sample sintered by microwave for 20 min at (a) 1025 °C and (b) 1075 °C. Reprinted by permission from (Nature/springer/Journal of Electroceramics) (Kumar et al.) Copyright (2018) [44]

Thus, the CCTO microstructure has well developed grains and grain boundaries. The grain boundaries are very thin as compared to that of grains. The authors showed that increasing the sintering temperature increases the grain growth in the ceramic as well as the densification (from 94 to 97%). At room temperature, a giant dielectric constant of 53300 and a small loss tangent of 0.2 at 100 Hz were found in CCTO sample sintered at 1075 °C for 20 min. It was

found that CCTO microstructure was electrically heterogeneous due to grain resistance of 8  $\Omega$  and grain boundary resistance of 350000  $\Omega$ . This confirms that giant dielectric constant in CCTO is related to inter-barrier layer capacitance.

Ouyang *et al.* [45] used microwave sintering in order to obtain CCTO ceramics. The authors explained that the fundamental difference between conventional sintering and microwave sintering is the difference of the heating mechanisms. The dielectric properties of the ceramics depend on their microstructure. In the microwave sintered samples, an increase in the sintering time decreases the value of the relative permittivity and the electrical loss. While for conventional sintering ceramics, an increase in the time of sintering increase the values of the permittivity and dielectric loss. This difference in behavior between microwave and conventionally sintered ceramics was attributed to the difference in the microstructure.

Raval *et al.*[46] prepared three sets of samples; all of them sintered at 1223 K for 12 h then at 1423 K for 18 h. The first set was slowly cooled, the second one was quenched from the high temperature to liquid nitrogen and the third one was slowly cooled then treated in a domestic microwave (2.45 GHz) for 1h. They analyzed J-E graphs to investigate the I-V properties of different surfaces resulting from different treatments. They noticed that the maximum current density (J<sub>max</sub>) decreases from 327 mA/cm<sup>2</sup> for the slowly cooled sample to 254 mA/cm<sup>2</sup> and 234 mA/cm<sup>2</sup> for the quenched and the microwave samples respectively. This behavior was attributed (i) to the relation between surface morphologies (grain size and secondary phases) after quenching and microwave treatment and (ii) to the varistor property.

#### II.3 Spark Plasma sintering

Field assisted sintering techniques have become recently very important for the rapid preparation of fully dense ceramic powders. Among them, the novel technique of Spark Plasma Sintering is used for the superfast densification of ceramic nanoparticles within a few minutes. Spark plasma sintering (Figure 18) is a modified hot-pressing process where the ceramic powder compact is placed within a conducting die (mainly graphite), which is in turn heated via high DC or AC electric current density [47].

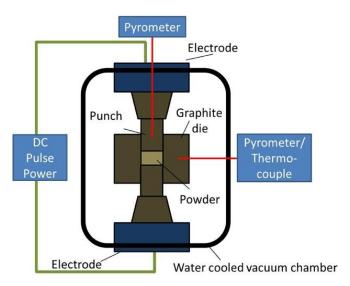


Figure **18**: SPS system configuration. Reprinted with permission from (Guillon et al.,2014). Copyright 2014 Creative Commons CC [47]

The SPS process is performed in partial and low vacuum (\* 3 Pa) in order to avoid oxidation of the graphite die at high temperatures. During the process, the sample placed in a conductive matrix and subjected to uniaxial pressure. In this sintering mode, series of DC pulses (pulse duration 3.3 ms, current 0.5 to 8 kA, voltage  $\leq$  10 volts) are applied during the sintering cycle. By this process it is possible to reach the sintering temperature extremely rapidly with temperature rise rates of up to 600 ° C. min<sup>-1</sup> maximum. As a result, grain growth is strongly inhibited and dense materials of submicron grains can be expected to be obtained at temperatures of about 100 degrees lower than the temperatures required for conventional sintering methods.

Three mechanisms affect the spark plasma sintering, such as enhancement of grain boundaries diffusion process by pulsed current, pressure application and resistance sintering. These three mechanisms have to be optimized in order to obtain a compact structure with grain-to-grain contact [34].

Kumar *et al.* [48] prepared CCTO ceramics by sintering CCTO powders using the SPS method. The sintering temperature used is 1050°C and the duration of sintering is 10 min under uniaxial pressure of 50 MPa. The morphology of the particles in the sintered pellet is shown in the figure 19.

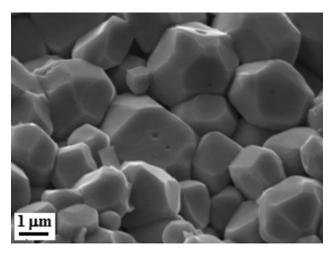


Figure 19: SEM image of CCTO pellets sintered at 1050  $^{\circ}$ C for 10 min using spark plasma sintering. Reprinted by permission from (Nature/springer/Journal of Materials science, Materials in Electronics) (Kumar et al.)-doi.org/10.1007/s10854-015-3275-x Copyright (2015) [48]

In 2017, Kumar *et al.* [49] obtained spark plasma sintered ceramics using a temperature of sintering of  $1050^{\circ}$ C and a duration of 30 minutes. The microstructure of the sintered ceramics (Figure 20a) showed that microstructure has highly compacted grains with grain boundaries. The average grain size is in range of  $12-15~\mu m$ . The density of sintered sample is measured to 97.5~% of theoretical density.

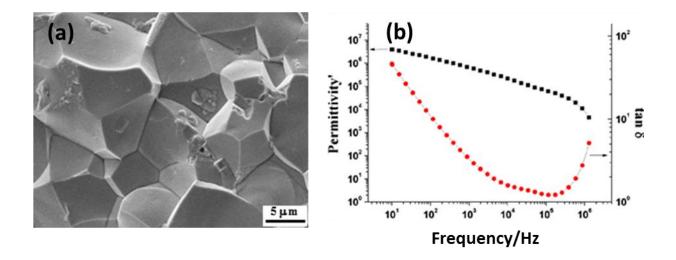


Figure **20**: (a) SEM image of fractured CCTO pellet sintered by spark plasma at 1050  $^{\circ}$ C for 30 min,(b) Frequency dependence of the dielectric constant and  $\tan\delta$  of spark plasma sintered CCTO samples. Reprinted by permission from (Nature/springer/Journal of Materials science, Materials in Electronics) (Kumar et al.)- $doi.org/10.1007/s10854-016-4418-4 \text{ Copyright (2016)} \quad \textbf{[49]}$ 

The frequency dependence of the dielectric constant and loss tangent of SPS sintered ceramics are shown in the following Figure 20b:

Dielectric constant and loss tangent of sintered samples was measured to  $1.7\times10^6$  and 11 at 100 Hz respectively. Using the impedance spectroscopy, the resistance of grain and grain boundary was calculated to be 10 and  $190\Omega$ , respectively. These resistances form the internal resistive barrier that result in a giant dielectric constant in CCTO.

They noticed an increase in grain boundaries resistance. The conductivity shows a nonlinear I-V response that confirmed the non-ohmic electrical grain boundaries properties of CCTO. A polarization is applied between two adjacent CCTO grains (Schottky diode), one of Schottky is forward polarized (semiconductor-insulator) in which the depletion contribution is reduced, and the second one is polarized in reverse (insulator-semiconductor) in which the depletion contribution is enhanced. These two depletions are unequal. By dropping the applied voltage, the reverse side keeps expanding while the forward one is fasten and this behavior results in an increase in width of the depletion region. The decrease of grain boundaries capacitance is induced by the increasing of the width of depletion region and thus non-ohmic electrical grain boundaries properties appears.

Ni et al. [50] prepared CCTO spark plasma sintered ceramics and compared them to conventionally sintered CCTO ceramics. In the SPS method, the obtained powders were added in to a graphite die with 12 mm diameter and sintered at temperatures from 750°C to 950°C for 5 min under a vacuum of 6 Pa. During the period of heating and soaking, a pressure of 30 MPa was applied to the sample. Then the as-sintered samples by SPS were polished and annealed in air at 800°C for 2 h to remove the residual carbon on the surface of samples. After annealing, the samples were polished again from both sides to remove the residue from outer layers.

The authors showed that the SPS ceramics showed a higher dielectric constant compared to conventionally sintered ceramics and they attributed this to the higher densification the sintered samples.

Lin *et al.* **[51]** prepared four different ceramic series that were SPS sintered at 900°C for 5 min, 900°C for 20min, 950°C for 5min and 950°C for 20min. Figure **21** shows the microstructure of the different ceramics obtained by SPS.

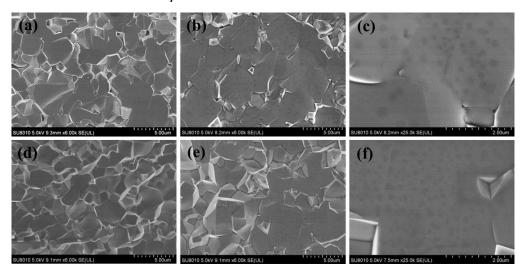


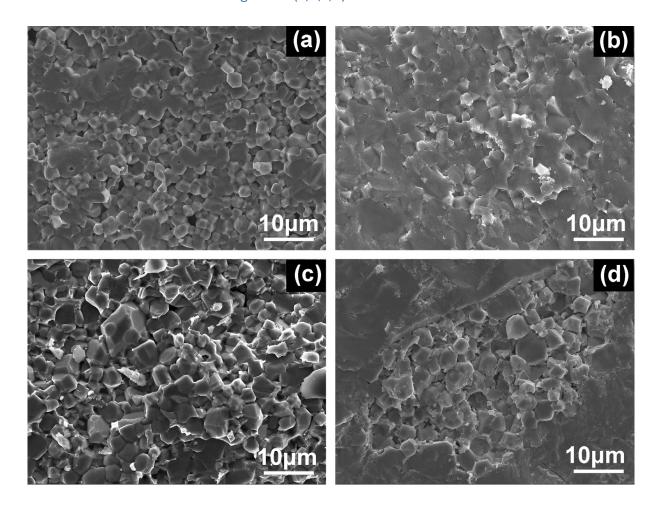
Figure **21**: SEM images of fractured cross-sections of CCTO ceramics prepared by SPS method: (a) SPS-900-5, (b) SPS-900-20, (d) SPS-950-5, (e) SPS-950-20 samples; the high magnifications for (c) SPS-900-20 and (f) SPS-950-20 samples with small inclusions. Reprinted with permission from (Lin et al.). Copyright 2018 Elsevier [51]

The authors concluded that the ceramics sintered at 900°C for 5 min have the largest  $E_b$  (~9.28 kV/cm) and  $\alpha$  (~21.5) value, which can be attributed to the synergistic effects of enhanced barrier height, large activation energy at grain boundaries, and the evolution of microstructure. Spark plasma sintering is an efficient method used to obtain a well and defined structure of CCTO ceramics; however it is a very costly method and not used widely.

#### II.4 Thermobaric treatment

High-pressure experimental techniques have been widely used in such fields as mineralogy, petrology, geophysics, and material science. Generally, there are three major high-pressure devices used in high-pressure experimental studies for the Earth and planets, including the piston-cylinder apparatus, the multianvil apparatus (MAA), and the diamond-anvil cell (DAC).

Each apparatus has its own advantages and unique applications [52]. High pressure and high temperature sintering methods have been recently used to prepare CCTO ceramics [53,54]. In order to study the properties of the CCTO ceramics prepared by thermobaric treatment, Xu et al.[53] prepared quenched CCTO at 1000°C/10 min after it had been subjected to a high quasihydrostatic pressure of 9 GPa. Such high pressure and high temperature treatment (HPT) result in significant changes of the crystallochemical parameters. The microstructures of the obtained ceramics are shown in Figure 22 (a,b,c,d):



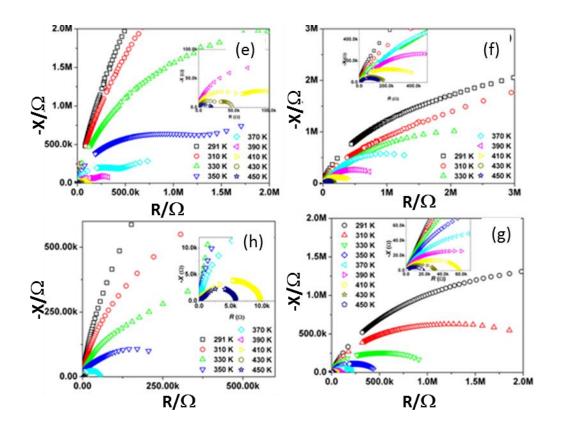


Figure 22: Fracture view field-emission scanning electron microscopy micrographs of (a) O2-CCTO, (b) O2-TBT-LN2, (c) LV-CCTO and (d) LV-TBT-LN2, Complex impedance spectra of CCTO ceramics in the frequency range of 20 Hz–3 MHz at various high temperatures: (e) O2-CCTO, (f) O2-TBT-LN2, (g) LV-CCTO and (h) LV-TBT-LN2.

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The samples sintered in vacuum show a little larger grain size of  $\sim 10 \mu m$  than the others, whereas the oxygen sintered samples have more uniform and much finer grain size of about 3–5  $\mu m$ . Gain boundaries tend to become blurred after thermobaric treatment (TBT).

Figure 23 (e,f,g,h) shows an example of the impedance study done on the ceramics obtained by TBT.

The authors concluded that the grain boundary relaxation is responsible for the abnormal dielectric behaviors of TBT CCTO ceramics. It is affected by the sintering condition and especially TBT processing.

Mao et al. [54] prepared the Calcium copper titanium oxide (CCTO) ceramics using the following procedure: Ceramics were quenched in air and liquid nitrogen separately after being

subjected to sintering in low vacuum and thermobaric treatment (TBT) at 9 GPa and 1000 °C for 10 min. The microstructures of the obtained ceramics are shown in Figure 23:

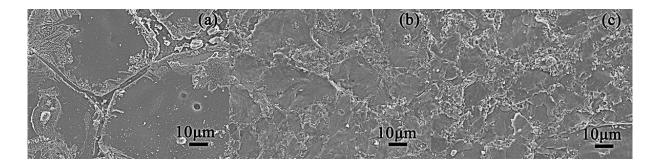


Figure **23**: FEG-SEM cross-section images of (a) CCTO, (b) CCTO-TBT-LN2 and (c) CCTO-TBT-Air ceramics. Reprinted with permission from (Mao et al.). Copyright 2018 Elsevier [54]

The authors observed that after TBT and quenching the grain size decreases tremendously and the grain boundary becomes fuzzy. From impedance study, the authors concluded that the dielectric relaxation of CCTO should be originated with the grain boundary that can be apparently affected by the extreme conditions of TBT and quenching.

It is clear from this section that using different sintering method lead to different microstructures and different dielectric properties as shown in Table 2. Despite the long duration and the high energy used for conventional sintering, this method gives best results of dielectric properties comparing with others, especially for dielectric loss. After reporting the manufacturing methods of CCTO; next section will discuss the insertion of one or two elements into the crystalline lattice in order to investigate their effects on dielectric properties.

Table **2** : Resuming the sintering method, different temperature and duration used and their influence on permittivity ( $\varepsilon'$ ) and dielectric loss ( $\tan \delta$ )

Sintering method	Precursors	Temperature	ε΄	$tan\delta$	References
Conventional Sintering	CaCO <sub>3</sub> , TiO <sub>2</sub> , CuO	1100°C/12h	~104	-	[38]
(CS)					
Microwave Sintering	$Ca(NO_3)_2.4H_2O$ ,	950°C	$3.14 \times 10^{3}$	0.161	[42]

	$Cu(NO_3)_2.3H_2O$ ,	(2.54GHz,1.25KW)			
	$C_{16}H_{36}O_4Ti$				
Spark Plasma Sintering	CaCO <sub>3</sub> , TiO <sub>2</sub> , CuO	900°C/5min	<b>10</b> <sup>5</sup>	-	[46]
Thermobaric Treatment	CaCO <sub>3</sub> , TiO <sub>2</sub> , CuO	CS: 1100°C/24h	10 <sup>3</sup>	~10	[50]
(TBT)		TBT:1000°C/10m			
		in (9GPa)			

# **III. Doping of CCTO**

The first part of this review has shown that copper calcium titanate is a material of choice for the fabrication of ceramic capacitors because it has an extremely high dielectric constant. The doping of this material by different types of ions can change its electrical properties (relative permittivity, losses, Curie temperature) and lead to other uses. The copper calcium titanate may allow the partial exchange of one, two or three cations by other cations of the same or different valences. It is necessary that the size, charge, and mass of the surrogate ions be compatible with the host site. Doping element or dopant is like an impurity inserted into the element in low concentration to alter some electrical or optical properties, in crystalline materials. These dopants enter into the crystal lattice and take a place of a basic element. Many studies have been performed on the doping of CCTO by different elements and most recently the co-doping of CCTO by two different elements at the same time. This section is divided into two parts, the first one treated the one element doping CCTO and the second part treated the two elements doping.

#### III.1 Doping of CCTO by one element:

Doping is crucial for determining physical properties and applications for various materials especially semiconductors. Fundamentally, a good dopant should achieve an ideal solubility in its host material and should exhibit a shallow defect level. However, there exist some fundamental doping bottlenecks, which strongly affect the device performance.

In order to enhance dielectric properties, doping CCTO was one of the investigations; it is an insertion of an atom into the structure lattice. Lee *et al.* [55] studied the effect of silver doping on the sintering temperature of CCTO. Ag dopant was added to CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> powders to reduce the sintering temperature in order to lower the fabrication costs. SEM figures of ceramics obtained from Ag-doped CCTO sintered at different temperatures are presented in Figure 24.

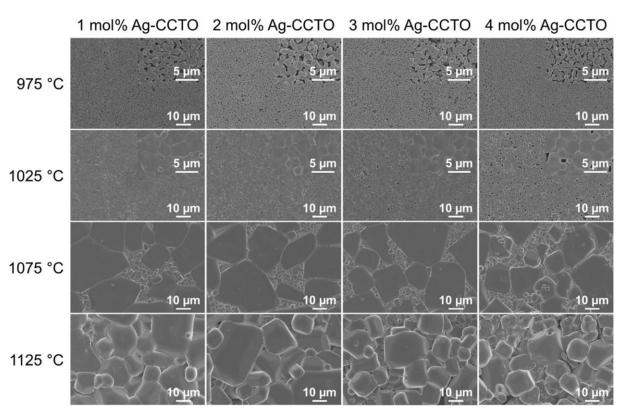


Figure **24**: Surface morphologies of 1–4 mol% Ag-doped CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> ceramics sintered from 975 to 1125 °C for 12 h. Reprinted with permission from (Lee et al.). Copyright 2017 Elsevier [55]

The SEM results indicate that a higher sintering temperature contributes to grain growth and densification, except for the Ag-doped CCTO ceramic specimens sintered at 1125 °C. Ag is believed to behave as a liquid-phase sintering aid. The authors found that the sintering temperature needed for obtaining highly densified ceramics was decreased from 1125 °C to 1075 °C. The relative permittivity of the 2% Ag ceramic increased compared to the undoped CCTO ceramic.

The dependence of current density (J) as the function of the electric field (E) is investigated (Figure 25). They conclude that the leakage of current density increases while doping with Ag atoms (sintered at 1075°C). At 100 mV, the current density is 1.63 and 0.17 mA/cm<sup>2</sup> for 2% Ag dopant and undoped CCTO respectively.

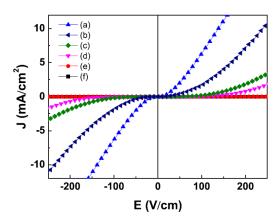


Figure **25**: Current density against electric field of (a) 2 mol% Ag-doped CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> based on nanoparticles sintered at 1075 °C, (b) 2 mol % Ag-doped CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> sintered at 1075 °C, (c) undoped CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> sintered at 1125 °C, (d) 2 mol% Ag-doped CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> sintered at 1125 °C, (e) 2 mol% Ag-doped CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> sintered at 1025 °C, and (f) 2 mol% Ag-doped CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> sintered at 975 °C. Reprinted with permission from (Lee et al.). Copyright 2017 Elsevier [55]

Xu *et al.* [56] studied the effect of bismuth doping on the electrical properties of CCTO. Ca  $_{3x/2}$ Bi<sub>x</sub>Cu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> (x = 0:0, 0.1, 0.2 and 0.3; BCCTO) ceramics were prepared by traditional solid-state sintering method. They observed a drastic grain size reduction with bismuth doping.

The doping of CCTO by Cobalt was studied by Mu et al. [57], Kafi et al. [58] and Wang et al. [59].

Mu *et al.* [57] prepared  $CaCu_3Ti_{1-x}Co_xO_{12}$  (x = 0, 0.2, 0.4) ceramics by a conventional solid state reaction. Both X-ray diffraction and energy dispersive X-ray spectroscopy confirmed the presence of Cu and Co rich phase at grain boundaries of *Co*-doped ceramics (Figure 26)

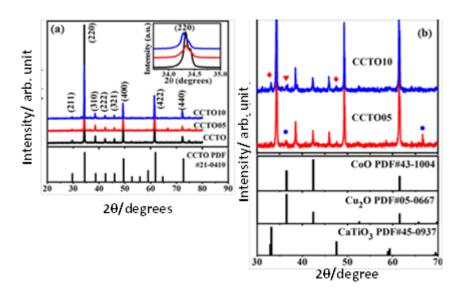


Figure **26**: X-ray powder diffraction patterns of (a) CCTO, CCTO05, and CCTO10 ceramics, the top right inset is an expanded view of (220) peaks; (b) expanded XRPD patterns at 2h¼30–70for CCTO05 and CCTO10 ceramics.

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The authors explained that the cobalt can exist in (II) and (III) oxidation states, and can occupy  $Cu^{2+}$  and  $Ti^{4+}$ , depending on its oxidation state. As compared with  $Ti^{4+}$  ( $r = 0.61 \, A^{\circ}$ ),  $Cu^{2+}$  ( $r = 0.57 \, A^{\circ}$ ), and  $Co^{3+}$  ( $r = 0.55A^{\circ}$ ),  $Co^{2+}$  has larger ionic radius ( $r = 0.75A^{\circ}$  for high spin state). According to the XRD patterns, the authors explained that the Cobalt is replacing the titanium.

Scanning electron microscopy micrographs of Co-doped samples showed a striking change from regular polyhedral particle type in pure  $CaCu_3Ti_4O_{12}$  (CCTO) to sheet-like grains with certain growth orientation. The authors showed that the dielectric constant value was slightly changed by 5% and 10% Co doping concentration, whereas the second relaxation process was clearly separated in low frequency region at room temperature. A multi-relaxation mechanism was proposed to be the origin of the colossal dielectric constant.

Kafi *et al.* [58] prepared CaCu<sub>3-x</sub>Co<sub>x</sub>Ti<sub>4</sub>O<sub>12</sub> (CCCTO, x = 0, 0.2, 0.4 and 0.6) ceramics using a semi wet method. Their results showed that the dielectric constants of the as-prepared samples in the frequency range of 50 Hz-200 kHz, at room temperature, are reasonably high  $(1.7 \times 10^4 \le \epsilon \le 6 \times 10^4)$ . It was also found out that the dielectric loss  $(\tan \delta)$  of the prepared samples decreased by increasing the cobalt concentration at low and middle frequencies.

Wang et al. [59] showed that the doping of CCTO by 5% of Co improved the dielectric

properties and gave dielectric constant  $\varepsilon' \approx 7.4 \times 10^4$  and dielectric loss  $\tan \delta \approx 0.034$  at room temperature and 1 KHz. The authors explained that the Cobalt replaces the Copper ion in the CCTO structure (Figure 27)

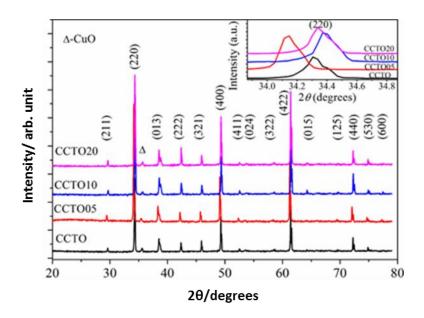


Figure **27**: XRD patterns of the pure and various Co-doped CCTO ceramics. Inset shows the enlarged view of the diffraction strongest (220) peak. Reprinted with permission from (Wang et al.) by Oxford University Press and Copyright Clearance Center 2018 [59]

The main XRD peaks correspond to a body-centred cubic CCTO structure with space group Im3 indexed. The secondary-phase peak at  $\sim 35.5^{\circ}$  ascribed to CuO phase is observed in all tested samples, indicating the precipitation of the liquid CuO-rich phase at GBs. Furthermore, because the absence of CuO phase in CCTO ceramic with 5% Cu deficient is reported elsewhere, the presence of CuO phase in Co-doped CCTO samples preliminarily confirms that the doped Co initially prefers to substitute at the Cu site.

Swatsitang *et al.* [60] prepared  $CaCu_{3-x}Cr_xTi_{4}O_{12}$  (x=0-0.2) via a polymer pyrolysis route. Best values for the relative permittivity and the loss tangent were obtained for the composition x = 0.08 with a dielectric constant value of 7156 and a low dielectric loss value of 0.092. These values are due to the increase in the grain boundaries resistance caused by the reduction of oxygen vacancies.

The influence of Erbium doping on the electrical behavior of  $CaCu_3Ti_4O_{12}$  was studied by Sakthisabarimoorthi *et al.* [61]. They prepared pure and Er doped CCTO ceramics by simple solgel method. The XRD pattern obtained confirmed that the addition of Er did not affect the crystallinity of CCTO. High dielectric constant ( $\varepsilon_r$ =26.749) was found for Er doped  $CaCu_3Ti_4O_{12}$  ceramics.

Li *et al.* [62] reported the effect of Europium (Eu) on the dielectric properties of CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub>. The experimental results show that the doping of Eu on a calcium (Ca) site improves the dielectric loss and decreases the dielectric constant of CCTO. The authors explained this result because of the lack of the oxygen vacancies in the samples.

An enhancement of grain growth is produced with F<sup>-</sup> doping CCTO studied by Jumpatam *et al.* [63] as shown in Figure 28.

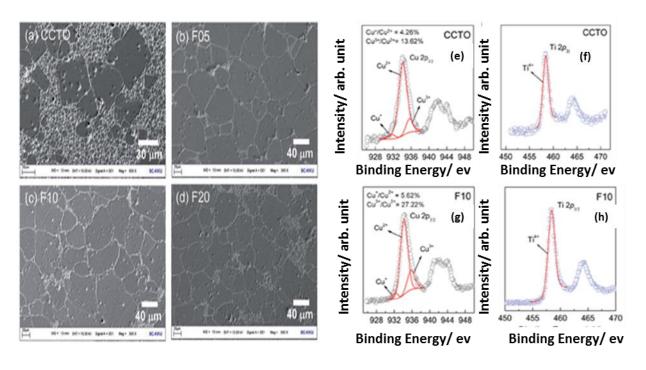


Figure 28: SEM images of polished surfaces of (a) CCTO, (b) F05, (c) F10 and (d) F20 samples, XPS spectra of CCTO and F10 samples: (e, f) Ti 2p regions and (g, h) Cu 2p regions. Reprinted from ref<sup>[63]</sup>. Copyright © 2017 Royal Society of chemistry.

The increase in the dielectric permittivity (98396 for F20) and the decrease of dielectric loss for a factor of 5 (tan=0.1) is attributed to the effect of F<sup>-</sup> that enhances the Schottky barrier height

at grain boundaries, in addition to the increase in Ti<sup>3+</sup> and Cu<sup>+</sup> concentrations (Figure **28** e,f,g,h) as a result of charge compensation leading to a large charge polarization space at grain boundaries.

Late *et al.* [64] have investigated the effect of Hf doping on the structural, dielectric and optical properties of CCTO. The authors considered that Hf substitute to Ti sites. From the XRD patterns, they deduced that when the Hf doping exceeds 2% some amount of HfO<sub>2</sub> remains unreacted in the sample. Furthermore, with in Hf doping both lattice parameters and structural coherency of CCTHO samples increases due to the higher ionic radius of Hf<sup>4+</sup> compared to the ionic radius of Ti<sup>4+</sup>. The authors studied the electrical properties using impedance spectroscopy; the obtained results are shown in Figure 29.

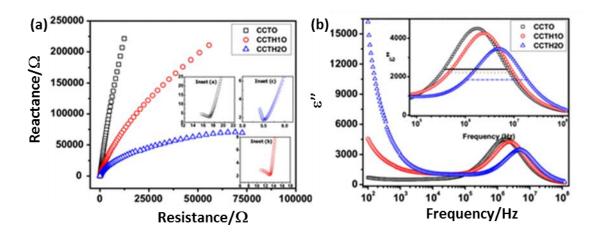


Figure **29** : a) Complex impedance plot for all samples. Inset a is showing magnified view of semicircular arcs corresponding to grain contributions (i.e. corresponding to highest probing frequencies) for CCTO, Inset b for CCTH1O and Inset c for CCTH2O. b) Variation of imaginary part of dielectric constant (ε'') as a function of frequency for all samples. Reprinted by permission from (Nature/springer/Journal of Materials science, Materials in Electronics) (Late et al.)- doi.org/10.1007/s10854-016-4505-6 Copyright (2016) [64]

They observed that with Hf doping overall grain boundary resistance decreases compared to that of pure CCTO compound. Further, Hf substitution increases dispersion of resistances between grain and the grain boundary. The authors concluded that the shift of relaxation frequency to higher values may be recognized to the decrease in the grain, grain boundary resistance and mean relaxation time. The improved dielectric properties with Hf doping may be

credited to the improved structural coherency, increased grain size and optical band gap of these samples. The results agree well with the IBLC model.

The influences of K<sup>+</sup> doping and sintering conditions on the microstructures and dielectric properties were analyzed and discussed by Wang *et al.* [65]. The authors observed that the grain size increases with the increasing sintering temperature and K<sup>+</sup> doping concentration.

The authors obtained giant  $\epsilon'$  of ~2.3 × 10<sup>4</sup> as well as relatively low tan $\delta$  of ~0.039 that can be observed in Ca<sub>0.99</sub>K<sub>0.02</sub>Cu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> ceramics sintered at 1060 °C for 8 h measured at RT and 1 kHz.

Chen et al. [66], Srivastava et al. [67] and Huang et al. [68] studied the effect of Lanthanum doping on CCTO. Chen et al. [66] employed the rare earth element La to replace Ca site and studied the La doping effects on the microstructure and the non-Ohmic properties of La-doped CCTO. From microscopic observations, the authors deduced that the low content of La ions ( $x\leq0.015$ ) doping hardly affects the crystal structure and the grain size. However, the significant change in microstructure is clearly revealed as  $x\geq0.02$ . With the increase of La content, the grain size is remarkably reduced to about 5  $\mu$ m and the grain boundaries are blurred to obscurity.

The authors also concluded that the nonlinear behavior of CCTO system is not only influenced by the grain size, but also controlled by the local electron density which would affect the chemical environment of defects.

Srivastava *et al.* [67] prepared a 1% La doped CCTO via semi wet route. La doped CCTO showed a slight increase in the value of the dielectric constant compared to undoped CCTO (5000 for undoped CCTO and 7000 for La doped CCTO) at room temperature. Permittivity and dielectric loss increase with increasing temperature for both undoped and doped CCTO. The effects of La<sup>3+</sup> doped in calcium copper titanate (CCTO) at Ca<sup>2+</sup> site and Cu<sup>2+</sup> site were examined by Huang *et al.* [68]. The doped compositions, La<sub>0.1</sub>Ca<sub>0.85</sub>Cu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> (LCCTO) ceramics and CaLa<sub>0.1</sub>Cu<sub>2.85</sub>Ti<sub>4</sub>O<sub>12</sub> (CLCTO) ceramics were prepared by the solid-state method. Ceramics were prepared under sintering temperatures ranging from 1040 to 1100°C. The microstructure of LCCTO ceramics presented a bimodal grain growth model (Figure 30)

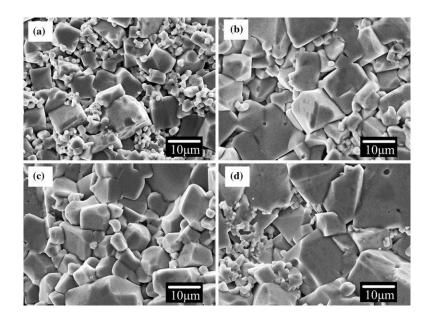


Figure **30**: SEM images of the surface morphologies of LCCTO sintered at a 1040  $\,^\circ$ C, b 1060  $\,^\circ$ C, c 1080  $\,^\circ$ C, d 1100  $\,^\circ$ C for 10 h. Reprinted by permission from (Nature/springer/Journal of Materials science, Materials in Electronics) (Huang et al.)- doi.org/10.1007/s10854-016-5244-4 Copyright (2016) [68].

It was found that La³+ doped at Ca²+ site achieved lower sintering temperatures than that doped at Cu²+ site in CCTO ceramics. The dielectric loss (tan  $\delta$ ) of LCCTO ceramics was about 0.05 at 40 kHz when the sample was sintered at 1080 °C. Dielectric constant ( $\epsilon$ ') of LCCTO ceramics was about 3.2  $\times$  10⁴ when the sample was sintered at 1100 °C, which was larger than CLCTO ceramics examined under the same process condition with different sintering temperature.

Mg doped CCTO was studied by Sun *et al.* [69] and Swatsitang *et al.* [70]. Sun *et al.* [69] prepared CaCu<sub>3-x</sub>Mg<sub>x</sub>Ti<sub>4</sub>O<sub>12</sub> ceramics with high  $\varepsilon'$  and very low tan $\delta$  by the sol–gel method. Very high values of relative permittivity and low values for dielectric loss were obtained for Mg doped CCTO ceramics :  $\varepsilon'$  of  $2.52\times10^4$  and tan $\delta$  of ~0.017 at 1 kHz and RT have been achieved for ceramics sintered at 1080°C for 8 h in the air atmosphere.

Swatsitang *et al.* [70] prepared the nominal CaCu<sub>3-x</sub>Mg<sub>x</sub>Ti<sub>4.2</sub>O<sub>12</sub> (0.00, 0.05 and 0.10) ceramics by sintering pellets of their precursor powders obtained by a polymer pyrolysis solution method at 1100 °C for different sintering times of 8 and 12 h. Very low loss tangent (tan $\delta$ ) < 0.009–0.014 and giant dielectric constant ( $\epsilon$ ')  $\sim 1.1 \times 10^4$ –1.8  $\times 10^4$  with excellent temperature coefficient ( $\Delta\epsilon$ ') less than  $\pm$  15% in a temperature range of – 60 to 210 °C were achieved. It was found that tan $\delta$  values decreased with increasing Mg<sup>2+</sup> dopants due to the increase of grain

boundary resistance (R<sub>gb</sub>) caused by the very high density of grain, resulting from the substitution of small ionic radius Mg<sup>2+</sup>dopants in the structure.

Wang *et al.* [71] accomplished a comparative study on the colossal dielectric constant behavior of the pure and Mn-doped CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> ceramics over a wide range temperature aiming at deeply understanding the role of the Mn doping effects on the physical origin of the colossal dielectric constant behavior. The nominally pure and doped CCTO ceramics by substituting 2% and 4 % Mn at Ti sites (abbreviated as CCTO, CCTMO-2, and CCTMO-4, respectively) were prepared using the conventional solid-state reaction method. The resultant materials were sintered at 1100°C for 10 h. XRD patterns showed a decrease in the lattice parameters and SEM micrographs showed that Mn doping is beneficial for grain growth (Figure 31).

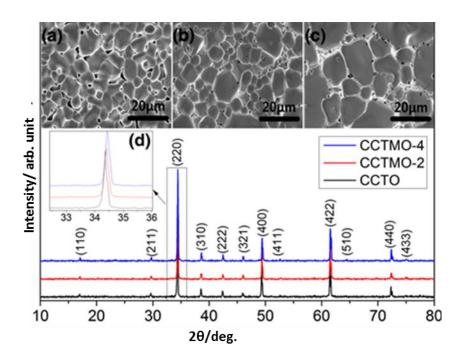


Figure **31**: XRD patens of CCTO, CCTMO-2, and CCTMO-4 ceramics. Inset shows the SEM micrographs of (a) CCTO, (b) CCTMO-2, (c) CCTMO-4, and (d) the enlarged view of the (220) reflection peaks. Reprinted by permission from (Nature/springer/Journal of Electroceramics) (Wang et al.)- doi.org/10.1007/s10832-016-0024-3 Copyright (2016)

Concerning the dielectric studies, the authors concluded that Mn doping is harmful for the CDC behavior and they attributed this to the decrease in the ratios of Ti<sup>3+</sup>/Ti<sup>4+</sup> and Cu<sup>3+</sup>/Cu<sup>2+</sup> and the concentration of oxygen vacancies. Their results confirm the multi-relaxation mechanism for the CDC behavior in CCTO and the CDC behavior is mainly dominated by Maxwell-Wagner contribution.

The perovskite-type CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> (CCTO) doped by molybdenum (Mo) and its dielectric properties and the temperature dependence of Electron Spin Resonance (ESR) has been investigated by Kouassi *et al.* [72] Substitution on Ti-site by Mo helps to increase the grain size of samples and therefore increase the dielectric constant according to the IBLC theory. There is no great difference between the ESR spectra of pure CCTO and CCTO doped by Molybdenum as a function of temperature (Figure 32).

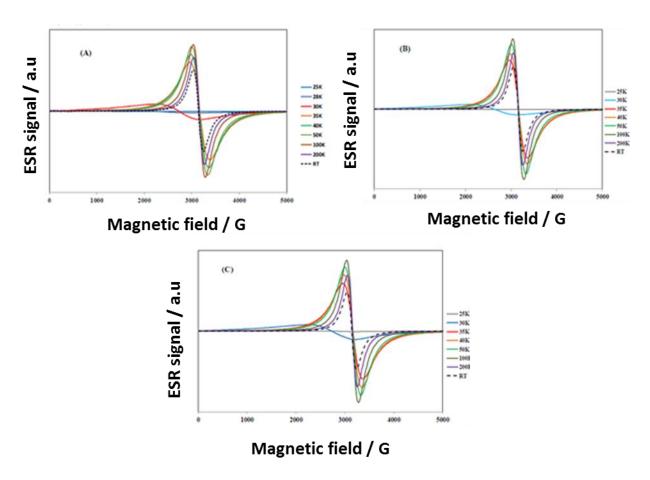
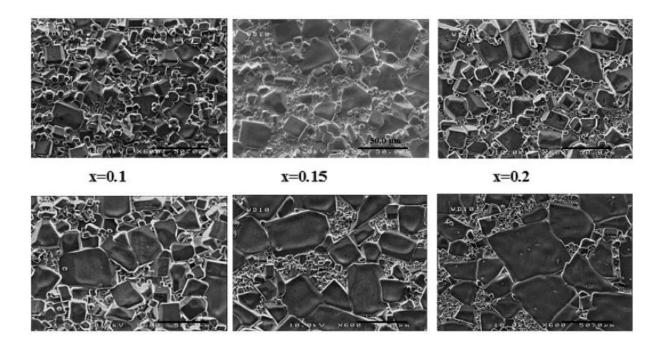


Figure **32**: Temperature dependence of ESR for pellets sintered at 1050°C of M0 (a), M0.05 (b) and M0.1 (c).

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Nickel doped CCTO were prepared and studied by Senda *et al.* [73], Wang *et al.* [74], Boonlakhorn *et al.* [75] and Sun *et al.* [9].

In the aim of increasing the relative permittivity and decreasing the dielectric loss of CCTO, Sun et al. [9] prepared  $CaCu_{3-x}Ni_xTi_4O_{12}$  (x = 0, 0.05, 0.1, 0.2) powders by the sol-gel method. The pellets were sintered at  $1000 - 1060^{\circ}C$  for 8h. A very low  $tan\delta$  value  $\sim 0.025$  was found at the  $CaCu_{2.95}Ni_{0.05}Ti_4O_{12}$  ceramic sintered at  $1060^{\circ}C$  for 8h with  $\epsilon' \sim 4.2 \times 104$  at about 1 kHz. Senda et al. [73] studied the influence of Ni doping on  $CaCu_{3-x}Ni_xTi_4O_{12}$  (x=0,0.05,0.075,0.1,0.2,0.3) ceramics sintered at  $1100^{\circ}C$  for 6, 12 and 24h in air. After sintering for 12h, they obtained for  $x \leq 0.2$  the pure phase and for x > 0.2  $CaTiO_3$ ,  $TiO_2$  and CuO as a secondary phase. The highest dielectric permittivity was recorded to the composition x = 0.2 ( $10^{5}$ ) with a slight decrease in loss tangent. Doping element enhance the cubic grain growth as shown in (Figure 33). Dielectric properties of all composition showed a dependence of frequency range. At high frequency (1 kHz) the permittivity and loss tangent decrease.



Wang *et al.* [74] reported good dielectric properties, a dielectric permittivity of  $\sim 1.5 \times 10^5$  and a low loss tangent of  $\sim 0.051$ , were obtained by optimization of dopant levels (CaCu<sub>2.80</sub>Ni<sub>0.20</sub>Ti<sub>4</sub>O<sub>12</sub>) and sintering conditions (1100 °C for 3 h). Boonlakhorn *et al.* [75] found that doping CCTO with Ni<sup>2+</sup> caused a great increase in its dielectric permittivity, by a factor of  $\sim 3$ .

Li *et al.* [76] fabricated CaCu<sub>3-x</sub>Ru<sub>x</sub>Ti<sub>4</sub>O<sub>12</sub> (x = 0, 0.03, 0.05 and 0.07) electronic ceramics. They noticed an inhibition of grain growth after doping with Ru. In general, during the sintering treatment, a liquid phase of Cu is formed at grain boundaries and ions diffuse through it to form a large grain. The authors performed EDX analysis on the grain boundaries, and they found that for pure CCTO, Ti, Ca, O and Cu ions are present in excess in the grain boundary region, while for Ru-doped CCTO, Ti and Ca atoms were the ones present in excess. It is well known that TiO<sub>2</sub> and CaO have high melting point and inhibit the formation of a liquid phase during the sintering process.

When doped with proper amount of Ru (x = 0.05), CCTO displays low dielectric loss (tan  $\delta$  < 0.05), while simultaneously maintains a decent dielectric constant ( $\epsilon$  > 80).

Cortes *et al.* [77] focused on CCTO doped with  $Sn^{4+}$ ,  $Ca_2Cu_2Ti_{4-x}$   $Sn_xO_{12}$  (0.0 < x < 4.0). They reported that the materials with low  $Sn^{4+}$  contents (x = 0.1 and 0.2) presented giant dielectric permittivity values, 166381 and 140845 respectively. They associated this to insulating grain boundaries with activation energies of 0.58 eV and 0.30 eV respectively, as well as conductive grains with activation energies of 0.04 eV and 0.08 eV.

Sahu et al. [78] investigated the effect of doping type on conduction and dielectric phenomena in 15% Sr doped CCTO. The Maxwell–Wagner model and interfacial polarization explains the higher dielectric constant of the material at higher temperatures.

Amhil *et al.* [79] recently prepared 0.05 Sr doped CCTO via a semi wet chemical route. Microstructural study showed that Sr concentration promotes grain growth in CSCTO ceramics. The dielectric properties were enhanced by the doping.

Tungsten doped CCTO was investigated by Singh *et al.* [80] CaCu<sub>3</sub>Ti<sub>4-x</sub> W<sub>x</sub>O<sub>12</sub> (x = 0.01, 0.03, and 0.05) ceramics were prepared by flame synthesis method. The dielectric property measurement shows that the relative permittivity ( $\varepsilon_r$ ) and dielectric loss (tan $\delta$ ) values in the measured frequency range at 328 K for W-doped ceramics were increased with increasing W content.

Kouassi *et al.* [81] again studied the effect of vanadium doping on the microstructure and dielectric properties of CCTO. They reported that the vanadium doping of CCTO system results in an increase of grain size, the grains being surrounded by melted-like grain boundaries. They added that in doped samples, above 1 kHz, a relaxation appears which is evidenced by a drop of real part of permittivity and a peak of its imaginary part. This relaxation phenomenon is very significant at relatively low doping rates and then decreases again as vanadium content increases.

Tang *et al.* [82] focused on the enhancement of dielectric properties of  $Y^{3+}$  donor doped CCTO. Grain growth in  $Ca_{1-x}Y_xCu_3Ti_4O_{12}$  was suppressed with increasing the concentration of dopant element.

The permittivity increases  $(8.03 \times 10^4)$  for x = 0.05 at 1 kHz and loss tangent decrease to 0.05 for x=0.03 in a frequency range between 1.5 kHz and 60 kHz. Figure 34 presents the relationship between dielectric constant and grain resistance in CYCTO ceramics in order to explain the dependence of increasing the dielectric constant and the grain growth.

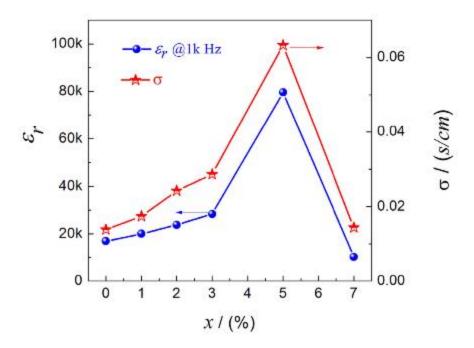


Figure **34**: Relationship of dielectric constant (1 kHz) and Grain resistance in  $Ca_{1-x}Y_xCu_3Ti_4O_{12}$  ceramics. Reprinted from (Tang et al.). Copyright 2018 Elsevier [82]

Xue *et al.* [83] studied the doping of CCCTO by different elements such as Y, Ta and Zr. They found that the grain growth changed with different doping element (Figure 35) even the dielectric properties are different. For Y<sup>3+</sup> doped CCTO, the dielectric constant increases and nonlinear property decreases while doping with La<sup>+</sup> leads to inverse results. Doping by Zr<sup>2+</sup> leads to the same results given for pure CCTO.

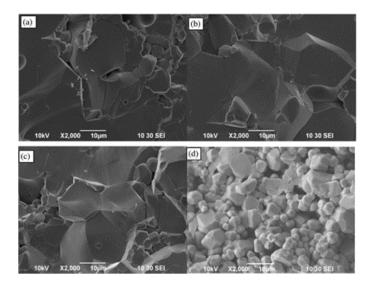


Figure **35**: SEM images of fracture morphologies for (a) pure CCTO, (b) Y-doped CCTO, (c) Zr-doped CCTO, (d) Tadoped CCTO. Reprinted from (Xue et al.). Copyright 2016 Elsevier [83]

Gonzales *et al.* [84] presented the results of Zr oxide doping of a CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> (CCTO) ceramic prepared by a solid-state reaction. Zr-doping controls the grain size growth, leading to a reduction of the grain size. For both dopant concentrations of 0.5 and 1 wt.%, all of the samples exhibited lower dielectric loss and a smaller dielectric constant than those of undoped CCTO. The sample doped with 0.5% of the non-stoichiometric ZrO exhibits a dielectric constant over 3200 and a dissipation factor of 0.02 at 1 kHz.

Xu *et al.* [85] reported a very high dielectric permittivity value of 7591 and a very low tanδ value of 0.023 at 1 kHz for CaCu<sub>3</sub>Ti<sub>3.8</sub>Zr<sub>0.2</sub>O<sub>12.</sub>

All obtained results are resumed in Table 3. Based on these results,  $F^-$  dopant element exhibits the highest dielectric properties where  $\epsilon$ =81,306 and  $\tan\delta$ =0.07. These can be caused due to the increase of grain boundaries resistivity and decrease of grains resistivity. Improvement of dielectric properties can be explained by the presence of free charge carrier concentration inside the semiconducting grains and Schottky barrier height at the grain boundaries respectively. A stronger intensity of interfacial polarization (Maxwell-Wagner polarization) is due to high charges concentration accumulated at the interface between grains and grain boundaries under an applied electric field [63].

Table  $\bf 3$ : dopant element, concentration, permittivity, loss tangent ( $\tan\delta$ ) and grain size of doped CCTO ceramic

Dopant	Concentration	$\varepsilon_{\rm r}$ (10 $^3$ Hz)	tan $\delta$ (10 $^3$ -10 $^6$ )	Grain size	References
Ni	x=0.2	>10 <sup>5</sup>	10-1	50 μm	[86]
Cr	x=0.08	7,156	0.092	60.3 μm	[60]
Υ	x=0.5	8.03*10 <sup>4</sup>	~ 0.01	2-4 μm	[82]
Co	5%	7.4*10 <sup>4</sup>	0.034	48.5 μm	[59]
Er	x=0.1	26,749	-	200 nm	[61]
Sr	x=0.2	>104	~ 0.3	~20 μm	[87]

x=0.6	6×10 <sup>4</sup>	0.15	75 μm	[58]
2mol%	~21,250	0.04	3-5 μm	[88]
x=0.1	~2.52×10 <sup>4</sup>	0.017	~2-20 μm	[69]
x=0.05	~31,125	~ 0.14	~55 μm	[83]
x=0.05	~22,260	~ 0.02	~32 μm	[83]
x=0.05	~17,500	~ 0.01	~4µm	[83]
x=0.05	~3 ×10 <sup>4</sup>	~ 0.013	~45.65 μm	[89]
x=0.05	$\sim 8\times 10^3$	~ 0.013	~2.52 μm	[89]
x=0.2	140,845	0.71	4.17 μm	[77]
x=0.025	$4.8\times10^{5}$	0.566	~20.2 µm	[90]
x=0.025	$2.1 \times 10^{5}$	0.129	~129.6 μm	[90]
x=0.02	32,000	0.05	1-2 μm	[91]
x=0.4	~2×10 <sup>4</sup>	~1.0	2.7 μm	[92]
x=0.15	~5×10 <sup>3</sup>	~0.1	3.9 μm	[92]
x=0.5	3,200	0.02	3.6 μm	[84]
x=0.1	81,306	0.077	~40-100 μm	[63]
x=0.7	$\sim 6.0 \times 10^{3}$	~0.4	2-4 μm	[76]
0.5%	34,994	0.68	2.1 μm	[93]
2%	$3.0 \times 10^{3}$	-	7-9 μm	[71]
x=0.01	2.3×10 <sup>4</sup>	0.039	4.28 μm	[65]
x=0.05	9,832	0.014	~2-6 μm	[94]
x=0.05	16,033	0.015	20-50 μm	[94]
	2mol% x=0.1 x=0.05 x=0.05 x=0.05 x=0.05 x=0.05 x=0.02 x=0.025 x=0.025 x=0.02 x=0.4 x=0.15 x=0.5 x=0.1 x=0.7 0.5% 2% x=0.01 x=0.05	2mol%       ~21,250         x=0.1       ~2.52×10 <sup>4</sup> x=0.05       ~31,125         x=0.05       ~22,260         x=0.05       ~17,500         x=0.05       ~3 ×10 <sup>4</sup> x=0.05       ~8 × 10 <sup>3</sup> x=0.2       140,845         x=0.025       2.1×10 <sup>5</sup> x=0.02       32,000         x=0.4       ~2×10 <sup>4</sup> x=0.15       ~5×10 <sup>3</sup> x=0.5       3,200         x=0.1       81,306         x=0.7       ~6.0×10 <sup>3</sup> 0.5%       34,994         2%       3.0×10 <sup>3</sup> x=0.01       2.3×10 <sup>4</sup> x=0.05       9,832	2mol% $^{2}1,250$ 0.04x=0.1 $^{2}.52 \times 10^{4}$ 0.017x=0.05 $^{3}1,125$ $^{3}0.14$ x=0.05 $^{2}2,260$ $^{3}0.02$ x=0.05 $^{2}1,500$ $^{3}0.01$ x=0.05 $^{3}1,125$ $^{3}0.01$ x=0.2 $^{3}1,125$ $^{3}1,125$ x=0.02 $^{3}1,125$ $^{3}1,125$ x=0.02 $^{3}1,125$ $^{3}1,125$ x=0.02 $^{3}1,125$ $^{3}1,125$ x=0.01 $^{3}1,125$ $^{3}1,125$ x=0.1	2mol%       ~21,250       0.04       3-5 μm         x=0.1       ~2.52×10 <sup>4</sup> 0.017       ~2-20 μm         x=0.05       ~31,125       ~0.14       ~55 μm         x=0.05       ~22,260       ~0.02       ~32 μm         x=0.05       ~17,500       ~0.01       ~4μm         x=0.05       ~3 ×10 <sup>4</sup> ~0.013       ~45.65 μm         x=0.05       ~8 × 10 <sup>3</sup> ~0.013       ~2.52 μm         x=0.2       140,845       0.71       4.17 μm         x=0.025       4.8 × 10 <sup>5</sup> 0.566       ~20.2 μm         x=0.025       2.1×10 <sup>5</sup> 0.129       ~129.6 μm         x=0.02       32,000       0.05       1-2 μm         x=0.4       ~2×10 <sup>4</sup> ~1.0       2.7 μm         x=0.1       ~5×10 <sup>3</sup> ~0.1       3.9 μm         x=0.5       3,200       0.02       3.6 μm         x=0.1       81,306       0.077       ~40-100 μm         x=0.7       ~6.0×10 <sup>3</sup> ~0.4       2-4 μm         0.5%       34,994       0.68       2.1 μm         2%       3.0×10 <sup>3</sup> -       7-9 μm         x=0.01       2.3×10 <sup>4</sup> 0.039       4.28 μm

## *III.2 Co-doping of CCTO by two elements:*

In general, co-doping can be efficient for increasing the dopant solubility, increasing the activation rate by lowering the ionization energy of acceptors and donors, and increasing the carrier mobility [95]. CCTO was largely doped with single elements but most of the heteroatomic substitutions that are employed to improve a dielectric property of the CCTO always worsen simultaneously another dielectric performance. This is the reason why many researchers are trying to perform co-doping on CCTO.

Boonlakhorn *et al.* [89] improved the dielectric properties of  $CaCu_3Ti_4O_{12}$  by co-doping with Y<sup>3+</sup> and Mg<sup>2+</sup> to simultaneously control the geometric and intrinsic properties of grain boundaries (GB), respectively. The authors found that the substitution of these dopants strongly suppressed the grain growth while enhancing the resistivity of an individual GB, respectively. This led to a great decrease in the loss tangent ( $tan\delta \sim 0.013$ ).

The authors prepared  $Ca_{0.925}Y_{0.05}Cu_{2.95}Mg_{0.05}Ti_4O_{12}$  (Y-Mg05) using a modified sol-gel method. The obtained compacted powders were sintered in air at 1070°C for 6h using heating and cooling rates of 5°C/min. The authors deduced that the resistance of the grain boundaries is increased by the addition of dopants.

The same authors doped CCTO by both  $Al^{3+}$  and  $Nb^{5+}$  [90]. They found that the substitution of  $(Al^{3+}, Nb^{5+})$  co—dopants into  $TiO_6$  octahedral sites of  $CaCu_3Ti_4O_{12}$  ceramics, which were prepared by a solid state reaction method and sintered at 1090°C for 18 h, can cause a great reduction in a low–frequency loss tangent ( $tan\delta\approx0.045-0.058$ ) compared to those of  $Al^{3+}$  or  $Nb^{5+}$  single–doped  $CaCu_3Ti_4O_{12}$ .

The authors deduced that the doping with Nb<sup>5+</sup> reduces the grain size while doping with Al<sup>3+</sup> results in a large increase in the mean grain size. Alternatively, the mean grain sizes of the codoped NA025 and NA05 ceramics were between the mean grain sizes of the single-doped Al025 and Nb025 ceramics and not much different that of the un-doped CCTO ceramic. They concluded that the simultaneous substitution of both Al<sup>3+</sup> and Nb<sup>5+</sup> ions can balance the driving and restorative forces for grain boundary (GB) migration.

The  $\epsilon'$  values of the single–doped AlO25 and NbO25 ceramics are larger than those of the codoped NAO25 and NAO5 ceramics. Nevertheless,  $\epsilon'$  values of both co–doped ceramics are still too large (> 10<sup>4</sup>). Interestingly, over the measured frequency range, the tan $\delta$  values of both co–doped ceramics are much lower than those of the single–doped ceramics as well as the un–doped CCTO ceramic.

The co-doping of CCTO by  $Al^{3+}$  and  $Nb^{5+}$  was also studied by Wen *et al.* [96] The authors concluded again a decrease in the dielectric loss of ceramics after codoping.

Boonlakhorn *et al.* [97] studied the dielectric properties of Sm and Zn codoped CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> ceramics. The values of the electrical permittivity and the loss tangent obtained for the different ceramics are shown in Table 4.

The authors observed that the  $\epsilon'$  and tan  $\delta$  values of the Sm05, SmZn05 and SmZn10 ceramics were lower than that of the CCTO ceramic over the measured frequency range. It should be noted that the low-frequency tan $\delta$  value of the single-doped Sm05 ceramic was much higher than that of the un-doped CCTO ceramic, while simultaneous substitution of Sm and Zn dopants into CCTO ceramics caused a great decrease in tan $\delta$  over the measured frequency range.

Ren *et al.* [98] co-doped CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> by Al<sup>3+</sup> and Bi<sup>3+</sup> elements to improve the electrical properties and enhance the varistor property of CCTO. The authors observed that the grain size homogenization was enhanced with co-doping. Although the average grain size shows not much difference, the grain size distribution of co-doped sample is much more uniform with smaller variance. The authors reported an enhancement of dielectric properties and varistor properties for 1mol% doping concentration. An increase of dielectric permittivity and decrease of dielectric loss to 0.04 at low and medium frequencies could be attributed to an increase of activation energy of dc conductance at grains boundaries as well as improvement in grains boundaries resistivity.

Bai *et al.* [99] prepared the CaCu<sub>3</sub> ( $Ti_{1-x}Fe_{x/2}Nb_{x/2}$ )<sub>4</sub>O<sub>12</sub> (x = 0.00, 0.50, 0.53, 0.57, 0.60) ceramics through the solid state reaction method with the pre-synthesis of the monoclinic precursor FeNbO<sub>4</sub>.

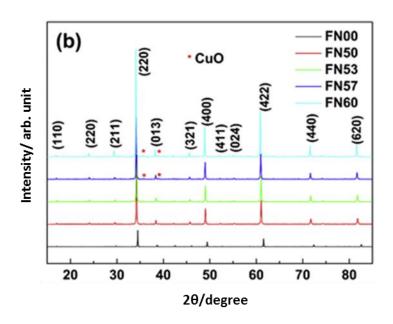


Figure 36: XRD patterns of CaCu<sub>2</sub> (Ti<sub>1-x</sub>Fe<sub>x/2</sub>Nb<sub>x/2</sub>)<sub>4</sub>O<sub>12</sub> powders with different percentage of codoping. Reprinted

from (Bai et al.). Copyright 2016 Elsevier [99]

From figure **36**, it has been noticed that the CaCu<sub>3</sub> ( $Ti_{1-x}Fe_{x/2}Nb_{x/2}$ )<sub>4</sub>O<sub>12</sub> powders kept single phase up to a codoping concentration of  $(Fe_{1/2}Nb_{1/2})^{4+}$  complex ions as high as 60%. The dielectric frequency spectra of CaCu<sub>3</sub> ( $Ti_{1-x}Fe_{x/2}Nb_{x/2}$ )<sub>4</sub>O<sub>12</sub> ceramics reveals the existence of Debyetype relaxations in measurement frequency range.

The effect of the addition of La and Zn on the dielectric properties of CCTO was studied by Rani et~al.~[100]. They prepared Ca0.95La0.05Cu3-xZnxTi4O12 (x=0.01, 0.025, 0.05 & 0.10) by conventional solid state technique. The ceramics were sintered at 1080°C for 6 hours with 5°C/min rate of heating and cooling. The microstructure of the prepared ceramics was shown to be highly affected by the codoping. The grain size of the composition was decreased with the increase in  $Zn^{2+}$  concentration. The electrical studies showed that  $Zn^{2+}$  substitution at  $Cu^{2+}$  site resulted in enhancement in grain as well as grain boundary resistance, consequently IBLC effect is destroyed.

Gonzalez et al. [92] studied the influence of Sr and La replacing Ca and Cu, respectively, on the intrinsic properties of CCTO. The powders Ca<sub>0.6</sub>Sr<sub>0.4</sub>Cu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub>, CaCu<sub>2.85</sub>La<sub>0.15</sub>Ti<sub>4</sub>O<sub>12</sub>,

 $Ca_{0.6}Sr_{0.4}Cu_{2.85}La_{0.15}Ti_4O_{12}$  and, pure  $CaCu_3Ti_4O_{12}$  were prepared by mechanical alloying. The microstructure analyzed by SEM showed a smaller grain size for the co-doped CCTO (Figure 37).

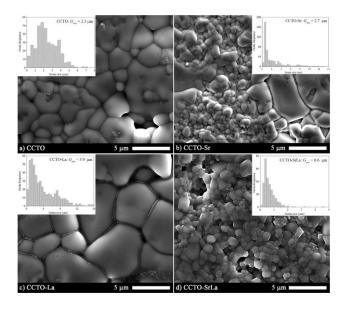


Figure **37**: SEM micrographs of pure and doped CCTO: a) Pure CCTO, b) CCTO-Sr, c) CCTO-La, d) CCTO-Sr La. Insert plots: Grain size distribution for each sample. Riprented from (Gonzalez et al.). Copyright 2018 Elsevier [92]

They also reported that the co-doped CCTO-Sr La ceramic showed the smallest  $tan(\delta)$  of 0.039 at 26.8 kHz compared to pure CCTO and single-doped ceramics. The co-doped sample reached a higher dielectric permittivity compared to the single-doped ceramics.

The effect of the codoping with Li<sup>+</sup> and Al<sup>3+</sup> on the dielectric properties of CCTO was studied by Sun *et al.* [101]. The codoped CCTO ceramics (CaCu<sub>3-2x</sub>Li<sub>x</sub>Al<sub>x</sub>Ti<sub>4</sub>O<sub>12</sub>, x = 0.05, 0.1, 0.15) were prepared by a sol–gel method and were sintered at 1020 –1080 °C for 8 h. The authors deduced that a very high dielectric constant of  $1 \times 10^5$  with good dielectric-frequency as well as dielectric-temperature stability can be achieved in CaCu<sub>2.8</sub>Li<sub>0.1</sub>Al<sub>0.1</sub>Ti<sub>4</sub>O<sub>12</sub> ceramic sintered at 1060 °C. The average grain sizes, resistivity and the non-Ohmic properties are also improved compared to pure CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub>.

The effects of co-doping on dielectric and Electrical responses of  $CaCu_3Ti_{4-x}$  ( $Nb_{1/2}In_{1/2}$ )<sub>x</sub>  $O_{12}$  Ceramics were studied by Boonlakhorn *et al.* [102].  $CaCu_3Ti_{4-x}$  ( $Nb_{1/2}In_{1/2}$ )<sub>x</sub>  $O_{12}$  ceramics, where x = 0, 0.025, 0.05, 0.10, and 0.20, were prepared via a solid state reaction method. All the green

bodies were sintered at 1090° C for 18 h. The mean grain size of CCTO was decreased by doping with Nb<sup>5+</sup> and In<sup>3+</sup>. Surprisingly the authors observed an increase in  $\tan\delta$  with the increase of x. They explained this by the change of microstructure and grain resistance.

Rani *et al.* [103] prepared  $Ca_{0.95}Nd_{0.05}Cu_3Ti_{4-x}Zr_xO_{12}$  (x = 0.01, 0.03 & 0.10) via solid method. SEM images demonstrated that grain size of the modified CCTO ceramics was controlled by  $Zr^{4+}$  ions due to solute drag effect. The mean grain size of the doped CCTO was decreased with the increase in subsequent concentrations of  $Zr^{4+}$  ions (Figure 38).

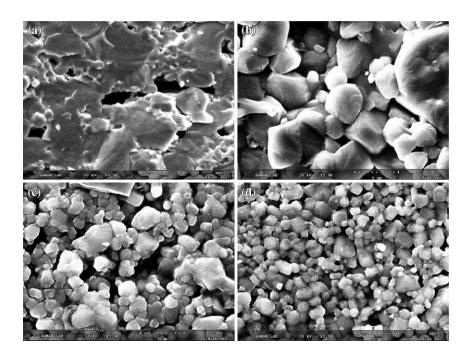


Figure **38**: SEM images of fractured surfaces of a CCTO, b CCTO1, c CCTO2 and d CCTO3, ceramics. Reprinted by permission from (Nature/springer/Journal of Materials science, Materials in Electronics) (Rani et al.)-doi.org/10.1007/s10854-018-9150-9 Copyright (2018) [103]

A huge value of dielectric permittivity ( $\epsilon_r \sim 16,902$ ) with nominal dielectric losses (tan  $\delta \sim 0.067$  at 1 kHz) was observed in a broad frequency range from  $10^3$  to  $10^5$  Hz for CCTO3 (x=0.03) ceramic. Thus, it is concluded that the both dopant ions have played an independent role to improve the dielectric performance of CCTO system.

The same authors [104] focused on the Sr and Zn codoped CCTO. They prepared  $Ca_{0.95}Sr_{0.05}Cu_3Ti_{4-x}Zn_xO_{12}$  (x = 0.01, 0.025, 0.05 & 0.10) powder by solid state method. They

observed that the Zn ion has the same effect as the Zr ion and that grain size of the modified CCTO ceramics was controlled by  $Zn^{2+}$  ions due to solute drag effect. Dielectric parameters observed to be improved for higher Zn/Sr ratio in the studied compositions. The  $Ca_{0.95}Sr_{0.05}Cu_3Ti_{3.9}Zn_{0.1}O_{12}$  ceramic composition shows a colossal dielectric permittivity of ~37,788 and loss ~ 0.049, which are stable within a broad frequency region. Reduced  $tan\delta$  over a broad range of frequency was well ascribed to the highly insulating grain boundaries.

Guo *et al.* [105] showed that the co-doping of CCTO by  $Ni^{2+}$  and  $Zr^{4+}$  by sol gel method can affect the microstructure of the ceramics and their dielectric properties. The grain size increases with the increase in the dopant concentrations. The authors also mentioned that they obtained a very low  $\tan\delta$  of 0.026 for the  $CaCu_{2.95}Ni_{0.05}Ti_{3.9}Zr_{0.1}O_{12}$  ceramic sintered at 1060 °C for 8 h with a very high  $\epsilon'$  value  $\sim 9.9 \times 10^4$  at about 9 kHz.

Du *et al.* [106] focused on the study of the codoping of CCTO by  $Y^{3+}$  on the A site and  $AI^{3+}$  on the B site in order to reduce the dielectric losses and simultaneously enhance the dielectric constants. Samples  $Ca_{1-x}Y_xCu_3Ti_{4-x}AI_xO_{12}$  with different doping concentrations x=0, 0.01, 0.02, 0.03, 0.05 and 0.07 have been prepared. No secondary phases were detected by XRD.

The dielectric properties showed that the dielectric losses of the doped ceramics are generally reduced and their dielectric constants are simultaneously enhanced across the frequency range up to 1 MHz. The doped sample with x = 0.05 exhibits the highest dielectric constant, which is well over  $10^4$  for frequency up to 1 MHz and is about 20% higher than the undoped sample.

Xu *et al.* [107] found that dielectric properties of CCTO were enhanced by its codoping with yttrium and zirconium. CaCu<sub>3</sub>Ti<sub>3.95</sub>Zr<sub>0.0</sub> O<sub>12</sub> (CCTZO), CaCu<sub>3</sub>Ti<sub>3.97</sub>Y<sub>0.03</sub>O<sub>11.985</sub> (CCTYO), and CaCu<sub>3</sub>Ti<sub>3.92</sub>Y<sub>0.03</sub>Zr<sub>0.05</sub>O<sub>11.985</sub> (CCTYZO) samples were prepared by citrate-nitrate combustion derived powders method. The SEM micrographs showed that Y<sub>2</sub>O<sub>3</sub> and ZrO<sub>2</sub> additive can inhibit grain growth. The authors explained that the smaller grain sizes of Zr doped CCTO may be due to the slow diffusion of the larger Zr<sup>4+</sup> ion substitutes of smaller Ti<sup>4+</sup> ion , another possible explanation is that addition to larger Zr<sup>4+</sup> ion, a high level of residual stress induced in the grain suppresses the grain growth of CCTO . Y doped CCTO also exhibits a smaller grain size, it may be due to the ability of Y<sup>3+</sup> ion that suppresses the grain growth rate of CCTO ceramics, and rearearth oxides could stop the grain boundaries from moving, which lead to fine grains .

A much better temperature and frequency stability of dielectric properties were realized in CCTYZO ceramics, and a low tan  $\delta$  of 0.039 was observed at room temperature and 10 kHz for CCTYZO ceramics.

Dielectric properties of  $Ca_{1-3x/2}Yb_xCu_{3-y}Mg_yTi_4O_{12}$  (x = 0.05, y = 0.05 and 0.30) prepared using a modified sol–gel method and sintered at 1070 °C for 4 h were investigated by Boonlakhorn *et al.* [108] They observed that Grain sizes of all co-doped samples were smaller than that of the un-doped CCTO sample. The authors concluded that the decrease in grain size of the co-doped CCTO ceramics was an important factor in reducing  $tan\delta$ . Enhanced resistivity of each GB layer was due to  $Mg^{2+}$  doping.

Rhouma *et al.* [109] synthetized Ca<sub>1-x</sub>Sr<sub>x</sub>Cu<sub>3-y</sub>Ni<sub>y</sub>Ti<sub>4</sub>O<sub>12</sub> for ( x and y =0 or 0.1), they found that Sr and Ni substitution leads to a ceramic densification and cubic grain form. They noticed that the dielectric permittivity increases (44,410) and the dielectric loss decreases (0.07) at low frequency of 1 kHz. In order to explain the grain growth, Raman spectra (Figure 39) measurements were carried out for a good determination of grain and grain boundaries. The three main modes (44 cm<sup>-1</sup>, 510 cm<sup>-1</sup>, 576 cm<sup>-1</sup>) appeared confirming the presence of CCTO at grains and grain boundaries, they found that CuO and TiO<sub>2</sub> exist as secondary phase on grain boundaries of the doped ceramics, which enhance the formation of liquid phase leading to grain boundary mobility and a grain growth.

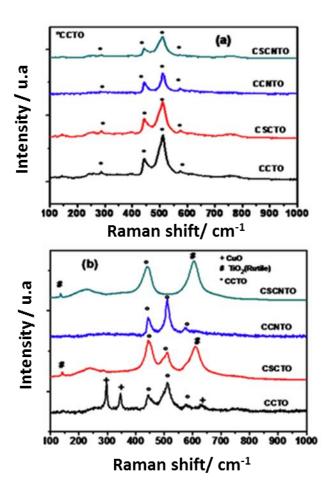


Figure **39**: Raman Spectra (a) on grains and on grain boundaries (b). Reprinted from (Rhouma et al.). Copyright 2017 Elsevier [109]

In order to enhance dielectric properties of CCTO, lee *et al.* [110] suggested forming an electrical path for a contact network. Normally it is an artificial formation in which metallic materials used as micro capacitors to immigrate between thin dielectric layers in the ceramic materials. In CCTO ceramics a metastable phase is required for this electric path. As their previous study they noticed the formation of metastable phase after sintering at 1125°C/2h. This phase is formed when there is not enough energy to complete the sintering reaction. Usually silver or nickel are the representative migration material, lee *et al.* choose silver [110]. First they sintered CCTO at 1050°C for 0.5, 2 and 12h, metastable phase is formed in the 2h sintered CCTO ceramics, and it is the liquid Cu phase. EDS analysis is used to approve the formation of metastable phase, by studying the stoichiometric report in different regions of the

material. In order to study the effect of Ag migration into CCTO (Figure 40), after sintering a post heating at 700°C/1h was employed to Ag coated-CCTO. Dielectric studies applied on CCTO ceramics showed that the permittivity increases after post-heating to about 565.9x10<sup>3</sup> at 1KHz.

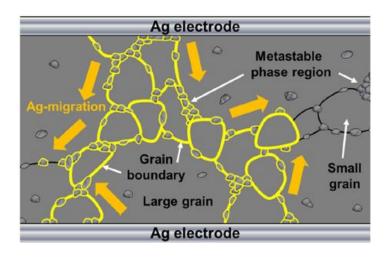


Figure **40**: Schematic of the Ag-migration phenomenon into metastable phase including grain boundary for the 2 h sintered CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> ceramics. Reprinted from Springer Nature/scientific reports (Lee et al). Copyright © 2018, Springer Nature [110]

The effect of co-doping CCTO on microstructure, permittivity ( $\epsilon_r$ ) and loss tangent ( $\tan\delta$ ) are resumed in Table 4. From these results, we can conclude that adding Yttrium to CCTO together with another dopant element can suppress the grain growth. Co-doping CCTO with Yttrium (Y) and Aluminum (AI) for instance yields a CCTO with a high dielectric constant ( $2*10^4$ ) and a low dielectric loss ( $\tan\delta$ =0.048).The results are explained by the following equation.3:

$$\varepsilon' = \varepsilon_{\rm gb} (d/t) \tag{3}$$

Where (d) is the grain size and (t) is the grain boundary thickness. From SEM we see that grain size decreases after co-doping and grain boundaries are thinner so the ration (d/t) is high, which lead to a higher dielectric constant and a lower dielectric loss.

Table 4: dopant element, concentration, permittivity, loss tangent ( $tan\delta$ ) and grain size of doped CCTO ceramic

Material	Concentration	εr(10³Hz)	$tan\delta(10^3-10^6)$	Grain size	References
				(μm)	

Y <sup>3+</sup> /AI <sup>3+</sup>	0.05	20×10 <sup>4</sup>	0.048	2-5	[106]
Bi/Al	1% mol	4,020	10-1	2.29-3.24	[98]
Sr/Ni	X = 0.1/0.1	44,410	0.07	35.50	[109]
Sr/Zn	x= 0.05/0.1	29,664	0.049	0.74	[104]
La/Zn	Zn (5-10%)	8,102	0.1	3-4	[100]
Y <sup>3+</sup> /Zn <sup>4+</sup>	3mol%/5mol%	10,196	~0.039	1.3-3.5	[107]
Sm/Zn	x=0.05/0.1	5,313	0.041	~2	[97]
Mg/Y	x=0.05/0.05	~104	~0.013	~3.73	[89]
Nb <sup>5+</sup> /Al <sup>3+</sup>	x=0.025	$4.1 \times 10^{4}$	0.058	~35.1	[90]
Nb <sup>5+</sup> /Al <sup>3+</sup>	x=0.05	$2.9 \times 10^{4}$	0.045	~34.6	[90]
Mg/Y	x=0.05/0.05	~104	~0.013	~3.73	[89]
Nb <sup>5+</sup> /Al <sup>3+</sup>	x=0.025	$4.1 \times 10^{4}$	0.058	~35.1	[90]
Nb <sup>5+</sup> /Al <sup>3+</sup>	x=0.05	2.9×10 <sup>4</sup>	0.045	~34.6	[90]
Sr/La	x=0.4/0.15	~4×10 <sup>4</sup>	~0.05	0.6	[92]
$Ni^{2+}/Zr^{4+}$	x=0.05/0.1	~2×10 <sup>4</sup>	0.026	4.75	[105]
LiF	0.5%	34,994	0.68	2.1	[93]
Yb/Mg	x=0.05/0.3	~104	0.018	2.32	[108]
FeNb	x=0.5	8.0×10 <sup>4</sup>	~0.8	1.9	[99]

# IV. Applications:

CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> showed exceptions dielectric properties useful for capacitors applications. Due to its outstanding structure where both atoms Ca<sup>2+</sup> and Cu<sup>2+</sup> with different ionic radius shared A site, CCTO can be used as well in photocatalytic application and especially in visible light. In addition CCTO is an antiferromagnetic compound; it is used to form composites with magnetic properties useful for antennas, GPS and other applications. In this section photocatalytic and magnetic properties will be reported.

#### IV.1. Photocatalytic properties

Accelerated industrial development and population growth forced science to find "green solutions" to solve problem of pollutions, by using a renewable energy such as visible light. The decomposition reaction of pollutants and pharmaceutical waste occurs only upon UV lights, in which UV light shared 4% of wavelengths with visible light [8,111]. TiO2 is acclaimed as a UVlight photocatalytic. To enhance TiO<sub>2</sub> performance in visible light, many approaches investigate the doping of TiO<sub>2</sub> with metal transitions [112-114]. While doping, a disordered structure could appear in TiO2, limiting the efficiency of this approach. Perovskite structure ABO3 has been investigated because A site is shared by two cations without causing a disordered lattice [8]. CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> perovskite showed a good photo-catalytic reaction against water pollutants and pharmaceutical waste [8,110,111,115,116]. As mentioned above, the specific structure of CCTO is the key of this function. It is related to photo-induced charge transition from ground state Cu<sup>2+</sup>,Ti<sup>4+</sup> to excited state Cu<sup>3+</sup>,Ti<sup>3+</sup> that CCTO have a visible light activity and they observed a direct band transition with a small band gap (1.52eV) [8,111]. CCTO was prepared using oxalate route to decompose pharmaceutical waste (erythrosin (dye), ciprofloxacin (antibiotic) and estriol (steroid))[111], sol-gel and solid route to break-down water pollutants such as 4chlorophenol [8].

Kushwaha *et al.*[111] demonstrate that after 40 min of exposure a total decomposition of erythrosine dye (solution turned from pink to colorless). As shown in Figure 41, the absorbance pic of erythrosine was observed at 525nm and starts to decrease after exposure of the pink solution to the visible light irradiation in presence of CCTO pellets.

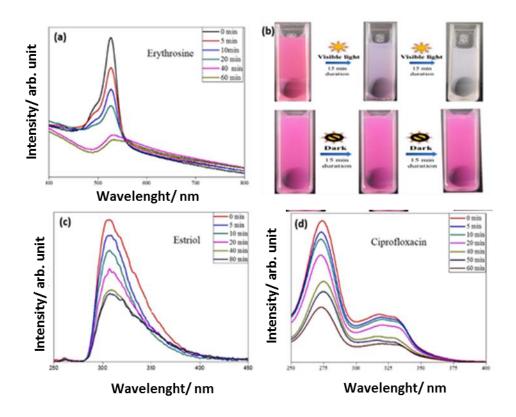


Figure **41**: (a) Change in absorbance of Erythrosine (525 nm) (b) Color change in erythrosine under dark and light (Figure drawn by author H.S. Kushwaha) (c) Change in absorbance of Ciprofloxacin (276 nm) and (d) fluorescence emission of estriol (305 nm excited at 240 nm) with time in photocatalytic degradation using CCTO pellets under visible light ( $\lambda > 420$  nm). Reprinted from (Kushwaka et al). Copyright 2016 Creative Commons [111]

In 2017, *Hailili et al.*[116] used the molten salt method in order to synthetize CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub>. Five different salts were utilized to control the shape of crystals. By XRD, the formation of pure phase is confirmed for the five samples and no additional peaks for CuO or TiO<sub>2</sub> appear. It is well known that the presence of oxygen vacancy is very important for the photocatalytic behavior. For that, Electron Paramagnetic Resonance (EPR) measurements were carried out to investigate their presence in each sample. The measurements show that for all samples, the EPR signals are in the same position since all samples have the same Cu content. However samples with octahedron, nanorod and polyhedron shape samples have a large line width with high intensities in comparison with cubic shape samples indicating a high oxygen vacancy concentration. Photocatalytic test under visible irradiation are performed in the presence of tetracycline as pollutant. They deduced (Figure 45) that with octahedron shape, the decomposition of TC achieved 99.1 %, with higher constant k=1.1\*10<sup>-1</sup>min<sup>-1</sup> (first low of kinetics). These results are

explained by 2 reasons: (i) the defects that enhance the active sites and (ii) an effective separation of electron-hole pairs to produce high efficiency in photocatalytic activity.

In order to enhance pollutant decomposition under visible light, *Hailili et al.*[117] synthesized a single crystal of CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> octahedron by molten salt. This crystal contains oxygen vacancies, metal deficiencies of Cu<sup>+</sup> and Ti<sup>3+</sup> and coexposed facets of ({001},{111}).

In CCTO (perovskite type ABO<sub>3</sub>), Ca and Cu atoms share the same A site and Cu is bonded to O atom (CuO<sub>4</sub>) and to TiO<sub>6</sub> octahedron with one O atom, to form TiO<sub>6</sub> and CuO<sub>4</sub> cluster. So any distortion of cluster or Ti displacement in TiO6 causes a defect in the crystallite structure of CCTO and results in an imperfection. The defect was confirmed in EPR measurement by the presence of the characteristic pic of Ti<sup>3+</sup> (3d<sup>1</sup>) and Cu<sup>+</sup> at g value of 1.982 and 2.077 respectively which cause a distortion for Ti-O-Ti bond and generate TiO5 distorted square structure formed from Ti<sup>3+</sup> and Ti<sup>4+</sup> and defects in CuO<sub>4</sub> planar. To characterize the heterojunctions facets, they calculate the band energy and density of states (DSO) of {001} and {111} surfaces by DFT. They deduced that there is a difference in level energy between conduction band (CB) and valence band (VB) levels of the exposed {001} and {111} facets; so facets heterojunctions can be formed. Under visible light irradiation, photoinduced electrons migrate from {001} to the exposed facets of {111} preferred as reduction sites because the electrons accumulation and {001} facets served as oxidation sites since photoinduced holes are accumulated on it. Figure 42 showed the degradation of tetracycline under visible light in presence of CCTO with and without defect. They deduced that 99.34% from tetracycline is decomposed in the presence of defect dual CCTO with large normalized rate constant of 1.06\*10<sup>-2</sup> min<sup>-1</sup>.

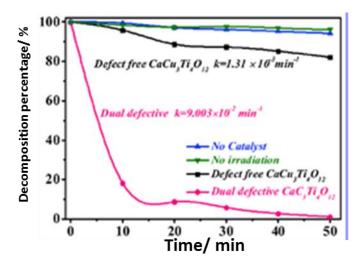


Figure **42**: Comparison visible light degradation ratio and corresponding apparent rate constants (k) of tetracycline in the presence of octahedron shaped dual defective and defect free CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub>. Reprinted fom (Haillili et al.).

Copyright 2019 IEEE [117].

Zhu et al. [118] tested the photo-assisted fenton-like process based on sulfate radicals using CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> as catalyst to remove pharmaceutical pollutants (ibuprofen) from water. Fenton-like process is based on sulfate radicals (SO<sub>4</sub>-), in which sulfate radicals with higher oxidative potential (2.5-3.1V) exhibit a higher oxidation power compared with hydroxyl radicals. Furthermore (SO<sub>4</sub>-) has a long life time (30-40µs) and a large range of working pH (2-9). They used molten salt synthesis to produce different shapes of CCTO catalyst by modifying sintering times. Cubic structures are formed at 775°C sintered for 6h (sample CCTO-6) and fibers are produced at 775°C sintered for 14h (sample CCTO-14). Photocatalytic behavior is tested for different systems, the ternary one (visible light/ CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub> (sample-14)/peroxymonosulfate) promotes ibuprofen's removal to 91.8% in 30 min. CCTO-14 showed oxygen vacancies and production of Cu<sup>+</sup> since Cu<sup>2+</sup> intensity decreases as shown in EPR measurement. It is related to the fact that under visible light, photogenerated-electrons are free to move into the crystallographic lattice and allow reducing Cu<sup>2+</sup> to Cu<sup>+</sup>, thus make enable peroxymonosulfate to generate sulfate radicals and reduce the rate of electron-holes recombination.

Pal et al. [119] synthesis CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub>-Carbon nitride composites as catalyst using low temperature thermal treatment (~150°C). They investigate the decomposition of methylene blue in the presence of H<sub>2</sub>O<sub>2</sub> activator, in the presence of LED light irradiation and the catalyst. They noticed that for 10 wt% CN in CCTO (sample: CN10CCTO), the decomposition of dye achieved 96% in 1h. Optical properties confirms charge transition from Cu<sup>2+</sup>, Ti<sup>4+</sup> ground states to Cu<sup>3+</sup>, Ti<sup>3+</sup> excited states respectively. From transient photocurrent study (Figure 43), they showed that CN10CCTO has the highest photocurrent value, which is attributing to the efficacy of charge separation of the charge carriers leading to an enhanced photocatalytic activity.

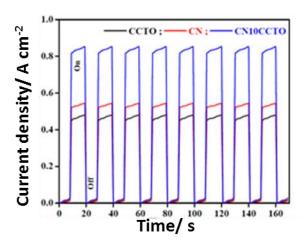


Figure **43**: Current density vs. time plot of CCTO, CN and CN10CCTO (10 wt% CN in CCTO). Reprinted from (Pal et al.). Copyright 2019 IEEE [119].

#### IV. Magnetic properties

A need to developed magnetic materials was the aim of researches in the 20<sup>th</sup> century. The best application is showed for materials where their coercivity and magnetization are optimized. Practical progress in magnetism largely depends on ferromagnetic materials, in which the mastery of coercivity was resulted from combined control of magnetocrystalline anisotropy and microstructure [120]. Ferromagnetic materials had a large range of magnetic dipoles that can be switched by applying a determined magnetic field [121]. The challenge is to correlate nanostructure properties and magnetic properties, and in order to explain this correlation, nanostructure materials were classified into different categories. Bulk materials or type D is one of this nanostructure materials, it is formed from grains and interfaces. With type D, the magnetic behavior cannot be predicted by applying theories for polycrystalline at nanoscales, because it is depending from grain boundaries and interaction [122].

 $CaCu_3Ti_4O_{12}$  is a bulk material with a antiferromagnetic behavior below Neel temperature  $(T_N=25K)$  studied with neutron diffraction and susceptibility measurements [123], due to spins (S=1/2) aligned antiferromagnetically on the A sites  $Cu^{2+}$  [57]. In order to enhance CCTO magnetic properties and to produce multiferroic material stable at room temperature, many investigations were performed by doping CCTO [57,123,124].

Wang et al. [59] doped CCTO ceramics using Cobalt (Co) by solid-state method. They showed from hysteresis loops, a weak ferromagnetism due to the superexchange interaction along Cu-O-Co-O-Cu path attributed to the small amount of Co substitution for the Ti site, instead of antiferromagnetic superexchange via Cu-O-Ti-O-Cu path.

Pansara *et al.* [124] synthesize  $CaCu_{3-x}Ti_{4-x}Fe_{2x}O_{12}$  (x=0.0-07) using solid state reaction. From M-H loops, they conclude that the material for x=0.0-0.3 presents an antiferromagnetic behavior while x=0.5 and 0.7 present a ferromagnetic properties. To explain the influence of Fe doping on CCTO, <sup>27</sup>Fe Mossbauer spectroscopy is used to investigate the oxidation number of Fe doped into the crystallite lattice. They conclude from hyperfine interaction parameters such as isomer shift (IS), Quadruple splitting (QS) and magnetic hyperfine field (HF) that Fe is in Fe<sup>3+</sup> form in which for x=0.5 and 0.7 Fe<sup>3+</sup> ions prefer A'-site. Fe<sup>3+</sup> in A'-site changes the superexchange interaction by increasing the Cu-Cu distance and increase the ferromagnetism by the dominant superexchange interaction through Cu(Fe)-O-Ti(Fe)-O-Cu(Fe) path.

Raval *et al.* [125] investigate the effect of ball milling, microwave assisted heating and rapid thermal cooling on magnetic properties in polycrystalline CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub>. Ball-milling induce curtails hybridization of empty Ti-3d orbitals with Cu-3d and O-2p orbitals and secondary phase formation. M-T curves show pure antiferromagnetic peak for unmilled sample in which Cu-Cu bond distance is 3.6963 Å, and a weak ferromagnetic peak for 16 h milling in which Cu-Cu bond is longest.

*Gavrilova et al.* [126] synthesized a CCTO based nanocomposite (SrFe<sub>12</sub>O<sub>9</sub>)<sub>x</sub>(CaCu<sub>3</sub>Ti<sub>4</sub>O<sub>12</sub>)<sub>1-x</sub> (x=0.01, 0.03, 0.07, 0.1) using solid state method. Electron spin resonance (EPS) showed two different lineshapes between x=0.03-0.07 group and x=0.01-0.1 group. For x=0.01, two lines appear, one is due to  $Cu^{2+}$  paramagnetic signal and the second is related to ferromagnetic signal from  $CaCu_3Ti_{4-y}Fe_yO_{12}$  solid solution. The position of ferromagnetic line shifts to g=2 (H=3300 Oe) while increasing the temperature. For x=0.03 and 0.07, TEM analysis confirmed the formation of nanostructured composites where SFO inclusions are inside the matrix. These results confirm the presence of two lines by EPS, in which one is attributed to the paramagnetic behavior of CCTO and second is a ferromagnetic line from SFO component. The EPS spectra for x=0.03 and 0.07 become less symmetric with increasing temperature.

### **Conclusion and perspectives**

Recent investigations focus on high dielectric material especially ceramics to energy storage and environmental application. Ceramics with specific dielectric properties are highly demanded because of their fast charge-discharge comparing with batteries. CCTO-perovkite is a ceramic founded in 2000, with high permittivity stable at a large range of frequencies and temperatures. In this review, an overview on the history of CCTO ceramics, the different manufacturing methods (synthesis and sintering) and the different elements used as dopant for CCTO is given. The effect of all these parameters on the microstructure and dielectric properties is discussed. The origin of high dielectric constant in CCTO ceramics is not fully understood. Many hypotheses were deducted from different studies. Intrinsic hypotheses is based on that high dielectric constant is the result of TiO<sub>6</sub> titled octahedral planar. By impedance spectroscopy, it was discovered that CCTO ceramics are heterogeneous, composed of semiconducting grains and insulating grain boundaries (IBLC model). Third hypothesis explain that this high dielectric constant comes from the interfacial reactions between electrodes used and the surface of the material. IBLC model is the most accepted due to that dielectric loss can be controlled with controlling grain boundaries, which allow CCTO to be useful in electronic applications. Studies focused on decreasing loss tangent with maintaining a high dielectric constant stable at large range of frequencies are summarized.

Different synthesis methods were used for the synthesis of CCTO: Solid state route, wet chemistry method at room temperature and normal pressure (sol-gel and coprecipitation), hydrothermal method (under high pressure), microwave and autocombustion methods. It is been observed that the dielectric properties highly depend on the synthesis technique. The best dielectric properties were shown by the ceramics prepared via the solid state route despite the high temperature used. Using wet chemistry method is a better approach to obtain a homogeneous and controlled microstructure. New trend in this area should be in the direction of finding new synthesis methods such as molten salt shielded synthesis able to give a homogeneous micro or nanostructures. Such techniques could help to reduce the synthesis temperature and achieve high permittivity and low loss tangent.

The use of different sintering techniques leads to different dielectric properties. Conventional sintering and spark plasma are one-step approaches for the formation of CCTO ceramics, contrariwise to microwave sintering and thermobaric treatment that need a pre-conventional sintering step. Discovering new sintering method using less energy is necessary for industrial applications of CCTO such a cold pressing sintering applied in ceramic field.

In order to enhance dielectric properties and maintain a high dielectric permittivity with a low dielectric loss, doping CCTO was one of the aims of researchers. Many atoms with different valence are chosen to be inserted into the crystalline structure in order to change the charge distribution of elements. From results showed in this review, it is clear that these elements have significant influence on dielectric properties and even on grain morphologies and boundaries. An optimal dopant could be inserted into the lattice without making distortion, but should suppress the grain growth in order to improve the dielectric properties. Till now, a huge variety of element was used as dopant for CCTO.

Because of its specific structure, several studies focused on photocatalytic function of CCTO and especially in the range of visible light for environmental issues. Pure CCTO showed an important photocatalytic performance in presence of pharmaceutical and water pollutants in visible light. CCTO showed as well an antiferromagnetic behavior based on neutron diffraction; several studies were performed in order to form multiferroic compounds, such as doping CCTO by different ferroelectric elements (Fe, Nb, Co..).

Despite his colossal dielectric properties, and to the best of our knowledge, CCTO is not used in industrial applications. In order to bring CCTO based devices on the market, more investigations should be performed in order to tune their properties for wide range of applications such as capacitor, varistor, GPS devices, and antennas as well as as photoelectrocatalytic materials able to degrades pharmaceutical and dye pollutants.

## **Keywords:**

-CaCu₃Ti₄O₁₂
-Dielectric
-Magnetic
-Perovskites
-Photocatalytic

## References

- [1]. . YX, Ferroelectric materials and their applications. Netherlands: North-Holland, 1991.
- [2]. Howard CJ and Stokes HT, J.Acta Crystallogr. Sect. B. 1998,54,782–789.
- [3]. Beskow G, Geol. Föreningen i Stock. Förhandlingar. 1924,46,738–743.
- [4]. FORRESTER WF and HINDE RM, Nature. 1945,156,177.
- [5]. Banerjee N and Krupanidhi SB. *J.Sci. Res.* **2010**,2 ,688–693.
- [6]. Subramanian MA, Li D, Duan N, Reisner BA, and Sleight AW, J. Solid State Chem. **2000**,151 ,323–325.
- [7]. Sinclair DC, Adams TB, Morrison FD, and West AR, J.Appl. Phys. Lett. 2002,80,2153–2155.
- [8]. Clark JH, Dyer MS, Palgrave RG, Ireland CP, Darwent JR, Claridge JB, and Rosseinsky MJ, *J. Am. Chem. Soc.* **2011**,133 ,1016–1032.
- [9]. Sun L, Zhang R, Wang Z, Cao E, Zhang Y, and Ju L, J.RSC Adv. 2016,6,55984–55989.
- [10]. Li W, Tang L, Xue F, Xin Z, Luo Z, and Du G, J. Ceram. Int. **2017**,43 ,6618–6621.
- [11]. Smith AE, Calvarese TG, Sleight AW, and Subramanian MA, J. Solid State Chem. 2009,182,409–411.
- [12]. Cohen MH, Neaton JB, He L, and Vanderbilt D, J. Appl. Phys. 2003,94,3299–3306.

- [13]. Li M, Sinclair DC, and West AR, J. Appl. Phys. **2011**,109 ,84106.
- [14]. Li M, Shen Z, Nygren M, Feteira A, Sinclair DC, and West AR, J. Appl. Phys. 2009,106,104106.
- [15]. Adams TB, Sinclair DC, and West AR, Phys. Rev. B. 2006,73,94124.
- [16]. Pandey RK, Stapleton WA, Tate J, Bandyopadhyay AK, Sutanto I, Sprissler S, and Lin S, *J.AIP Adv.* 2013,3 ,62126.
- [17]. Ghayour H and Abdellahi M, J. Powder Technol. 2016,292,84–93.
- [18]. Bhatti HS, Hussain ST, Khan FA, and Hussain S, J. Appl. Surf. Sci. 2016, 367, 291–306.
- [19]. Ahmadipour M, Ain MF, and Ahmad ZA, J. Nano-Micro Lett. 2016,8, 291–311.
- [20]. Lee G-J, Park E-K, Yang S-A, Park J-J, Bu S-D, and Lee M-K, J.Sci. Rep. 2017,7,46241.
- [21]. Yu H, Liu H, Hao H, Guo L, Jin C, Yu Z, and Cao M, J. Appl. Phys. Lett. 2007,91,222911.
- [22]. Thongbai P, Jumpatam J, Putasaeng B, Yamwong T, and Maensiri S, *J. Appl. Phys.* **2012**,112 ,114115.
- [23]. Fang T-T, Chung H-Y, and Liou S-C, J. Appl. Phys. **2009**,106,54106.
- [24]. Khadka P, Ro J, Kim H, Kim I, Kim J, Kim H, Min Cho J, Yun G, and Lee J, Asian. J. Pharm. Sci. **2014**, 9, 304-316.
- [25]. Tripathy N, Das KC, Ghosh SP, Bose G, and Kar JP, IOP Conf. Ser. Mater. Sci. Eng. 2016,115, 12022.
- [26]. Rao BG, Mukherjee D, and Reddy BM, J. Nanostructures Nov. Ther. 2017,1–36.
- [27]. Mao P, Wang J, Liu S, Zhang L, Zhao Y, and He L, J. Alloys Compd. 2019,778,625–632.
- [28]. Zhu B, Wang Z, Zhang Y, Yu Z, Shi J, and Xiong R, J. Mater. Chem. Phys. 2009,113,746–748.
- [29]. Kumar R, Zulfequar M, Sharma L, Singh VN, and Senguttuvan TD, *J.Cryst. Growth Des.* **2015**,15 ,1374–1379.
- [30]. Submitted T, The IN, Fulfillment P, Requirement THE, The FOR, Of D, Technology MOF, and Engineering C, **2009**.

- [31]. Lopera A, Ramirez MA, García C, Paucar C, and Marín J, J.Inorg. Chem. Commun. 2014,40,5–7.
- [32]. Masingboon C and Rungruang S, J. Phys. Conf. Ser. 2017,901,12101.
- [33]. German RM and German RM, J. Sinter. Adv. Mater. 2014,3–32.
- [34]. Jaworska L, Cyboroń J, Cygan S, Laszkiewicz-Łukasik J, Podsiadło M, Novak P, and Holovenko Y, IOP Conf. Ser. Mater. Sci. Eng. 2018,329 ,12004.
- [35]. Oghbaei M and Mirzaee O, J. Alloys Compd. **2010**,494 ,175–189.
- [36]. Barbier B, Combettes C, Guillemet-Fritsch S, Chartier T, Rossignol F, Rumeau A, Lebey T, and Dutarde E, J. Eur. Ceram. Soc. **2009**,29 ,731–735.
- [37]. Krohns S, Lunkenheimer P, Ebbinghaus SG, and Loidl A, J. Appl. Phys. 2008,103,84107.
- [38]. Ferrarelli MC, Sinclair DC, West AR, Dabkowska HA, Dabkowski A, and Luke GM, *J. Mater. Chem.* **2009**,19 ,5916–5919.
- [39]. Fiorenza P, Raineri V, Ebbinghaus SG, and Lo Nigro R, *J.CrystEngComm.* **2011**,13 ,3900–3904.
- [40]. Schmidt R, Pandey S, Fiorenza P, and Sinclair DC, J.RSC Adv. 2013,3,14580–14589.
- [41]. Turky AO, Rashad MM, Zaki ZI, Ibrahim IA, and Bechelany M, J.RSC Adv. 2015,5, 18767–18772.
- [42]. Chung S-Y, Kim I-D, and Kang S-JL, J.Nat. Mater. **2004**,3,774.
- [43]. Mishra RR and Sharma A, J. Composites Part A. **2016**, 81, 78-97.
- [44]. Kumar R, Zulfequar M, and Senguttuvan TD, J. Electroceram. 2018, 42, 41-46.
- [45]. Ouyang X, Cao P, Huang S, Zhang W, Huang Z, and Gao W, *J. Electron. Mater.* **2015**,44 ,2243–2249.
- [46]. Raval PY, Makadiya AR, Pansara PR, Sharma PU, Vasoya NH, Bhalodia JA, Kumar S, Dolia SN, and Modi KB, *J.Mater. Chem. Phys.* **2018**,212 ,343–350.
- [47]. Guillon O, Gonzalez-Julian J, Dargatz B, Kessel T, Schierning G, Räthel J, and Herrmann M, J. Adv. Eng. Mater. **2014**,16,830–849.
- [48]. Kumar R, Zulfequar M, and Senguttuvan TD, J. Mater. Sci: Mater Electron. 2015, 26, 6718-6722.

- [49]. Kumar R, Zulfequar M, and Senguttuvan TD, J. Mater. Sci: Mater Electron. 2016, 25, 5233-5237.
- [50]. Ni L, Fu M, Ren X, and Zhang Y, J. Mater. Sci. Mater. Electron. 2017,28, 10191–10198.
- [51]. Lin H, He X, Gong Y, Pang D, and Yi Z, J. Ceram. Int. 2018,44,8650–8655.
- [52]. Zhai S and Ito E, *J. Geosci. Front.* **2011**,2 ,101–106.
- [53]. Xu L-F, Mao C, Marchenkov V V., Sun K, Dyachkova T V., Tyutyunnik AP, Zainulin YG, Yang C-P, and Liang S-H, *J.Phys. Lett. A* **2018**,382 ,2861–2867.
- [54]. Mao C, Xu L, Marchenkov V V., Dyachkova T V., Tyutyunnik AP, Zainulin YG, and Yang C, *J. Ceram. Int.* 2018,44 ,20069–20074.
- [55]. Lee J-W and Koh J-H, J. Ceram. Int. **2017**,43,9493–9497.
- [56]. Xu LF, Sun K, Feng X, Xiao HB, Wang RL, and Yang CP, Int. J. Mod. Phys. B 2017,31,1750133.
- [57]. Mu C, Song Y, Wang H, and Wang X, J. Appl. Phys. **2015**,117 ,17B723.
- [58]. Kafi Z, Kompany A, Arabi H, and Khorsand Zak A, J. Alloys Compd. 2017,727, 168–176.
- [59]. Wang J, Lu Z, Deng T, Zhong C, and Chen Z, J. Eur. Ceram. Soc. 2018,38,3505–3511.
- [60]. Swatsitang E and Putjuso T, J. Eur. Ceram. Soc. 2018,38,4994–5001.
- [61]. Sakthisabarimoorthi A, Martin Britto Dhas SA, Robert R, and Jose M, *Mater. Res. Bull.* **2018**,106 ,81–92.
- [62]. Li M, Liu Q, and Li CX, J. Alloys Compd. **2017**,699 ,278–282.
- [63]. Jumpatam J, Putasaeng B, Chanlek N, Kidkhunthod P, Thongbai P, Maensiri S, and Chindaprasirt P, *J.RSC Adv.* **2017**,7 ,4092–4101.
- [64]. Late R, Rai HM, Saxena SK, Kumar R, Sagdeo A, and Sagdeo PR, J. Mater. Sci. Mater. Electron. **2016**,27 ,5878–5885.
- [65]. Wang Z, Guo J, Hao W, Cao E, Zhang Y, Sun L, and Xu P, J. Electroceramics **2018**,40, 115–121.
- [66]. Chen J, Li T, Dai HY, and Chen ZP, J. Defect Diffus. Forum 2017,373,241–244.

- [67]. Srivastava A, Am. J. Mater. Synth. Process. 2018,2,90.
- [68]. Huang X, Zhang H, Li J, and Lai Y, J. Mater. Sci. Mater. Electron. 2016,27, 11241–11247.
- ,345–350. Sun L, Zhang R, Wang Z, Cao E, Zhang Y, and Ju L, J. Alloys Compd. **2016**,663.
- [70]. Swatsitang E, Prompa K, and Putjuso T, J. Mater. Sci. Mater. Electron. **2018**,29 ,12639–12651.
- [71]. Wang C, Ni W, Zhang D, Sun X, Wang J, Li H, and Zhang N, J. Electroceramics 2016,36,46–57.
- [72]. Simplice Kouassi S, J.Adv. Mater. 2017,6,57.
- [73]. Senda S, Rhouma S, Torkani E, Megriche A, and Autret C, J. Alloys Compd. 2017,698, 152–158.
- [74]. Wang J, Lu Z, Deng T, Zhong C, and Chen Z, J. Am. Ceram. Soc. 2017,100, 4021–4032.
- [75]. Boonlakhorn J, Putasaeng B, and Thongbai P, J. Ceram. Int. 2019,45,6944–6949.
- [76]. Li W, Zhang T, Liu S, Lu Z, and Xiong R, J. Ceram. Int. 2017,43,4366–4371.
- [77]. Cortés JA, Cotrim G, Orrego S, Simões AZ, and Ramírez MA, J. Alloys Compd. 2018,735, 140–149.
- [78]. Sahu M, Hajra S, and Choudhary RNP, J.SN Appl. Sci. **2018**,1 ,13.
- [79]. Amhil S, choukri E, Ben Moumen S, Bourial A, and Essaleh L, *J.Phys. B Condens. Matter* **2019**,556 ,36–41.
- [80]. Singh L, Sin BC, Kim IW, Mandal KD, Chung H, and Lee Y, J. Am. Ceram. Soc. 2016,99,27–34.
- [81]. Simplice Kouassi S, Int. J. Mater. Sci. Appl. 2017,6,54.
- [82]. Tang L, Xue F, Guo P, Xin Z, Luo Z, and Li W, J. Ceram. Int. 2018,44, 18535–18540.
- [83]. Xue R, Zhao G, Chen J, Chen Z, and Liu D, J.Mater. Res. Bull. 2016,76,124–132.
- [84]. Espinoza-González R and Mosquera E, J. Ceram. Int. 2017,43,14659–14665.
- [85]. Xu D, Zhu Y, Zhang B, Yue X, Jiao L, Song J, Zhong S, Ma J, Bao L, and Zhang L, *J. Mater. Sci. Mater. Electron.* **2018**,29 ,5116–5123.
- [86]. Senda S, Rhouma S, Torkani E, Megriche A, and Autret C, J. Alloys Compd. 2017,698, 152–158.

- . 1026–1032, Huang X, Zhang H, Wei M, Lai Y, and Li J, J. Alloys Compd. 2017,708,
- [88]. Makcharoen W and Punsawat W.J. Mater. Today Proc. 2017,4,6234–6238.
- [89]. Boonlakhorn J, Putasaeng B, Kidkhunthod P, and Thongbai P, J. Mater. Des. 2016,92,494–498.
- [90]. Boonlakhorn J, Kidkhunthod P, Chanlek N, and Thongbai P, J. Eur. Ceram. Soc. 2018,38,137–143.
- [91]. Deng J, Sun X, Liu S, Liu L, Yan T, Fang L, and Elouadi B, J. Adv. Dielectr. 2016,06,1650009.
- [92]. Espinoza-González R, Hevia S, and Adrian Á, J. Ceram. Int. 2018,44,15588–15595.
- [93]. Porfirio TC and Muccillo ENS, J. Ceram. Int. 2016,42,12005–12009.
- [94]. Boonlakhorn J, Thongbai P, Putasaeng B, Yamwong T, and Maensiri S, *J. Alloys Compd.* **2014**,612 ,103–109.
- [95]. Katayama-Yoshida H, Nishimatsu T, Yamamoto T, and Orita N, *J. Phys. Condens. Matter* **2001**,13 ,8901–8914.
- [96]. Wen A, Yuan D, Zhu X, Zhu J, Xiao D, and Zhu J, Ferroelectrics **2016**,492 ,1–9.
- [97]. Boonlakhorn J and Thongbai P, J. Ceram. Int. **2017**,43 ,12736–12741.
- .652–658, Ren L, Yang L, Xu C, Zhao X, and Liao R, *J. Alloys Compd.* **2018**,768, 652–658.
- [99]. Bai L, Wu Y, and Zhang L, J. Alloys Compd. **2016**,661,6–13.
- [100]. Rani S, Ahlawat N, Punia R, Sangwan KM, and Khandelwal P, J. Ceram. Int. 2018,44, 23125–23136.
- [101]. Sun L, Ni Q, Guo J, Cao E, Hao W, Zhang Y, and Ju L, *J.Appl. Phys. A Mater. Sci. Process.* **2018**,124 ,0.
- [102]. Boonlakhorn J, Kidkhunthod P, and Thongbai P, J. Phys. Conf. Ser. 2017,901, 12078.
- [103]. Rani S, Ahlawat N, Sangwan KM, Rani S, Punia R, and Malik J, J. Mater. Sci. Mater. Electron. 2018,29 ,10825–10833.
- . 1112–1112, Rani S, Ahlawat N, Sangwan KM, Punia R, and Kumar A, J. Alloys Compd. 2018,769
- [105]. Guo J, Sun L, Ni Q, Cao E, Hao W, Zhang Y, Tian Y, and Ju L, J. Appl. Phys. A **2018**,124 ,635.

- [106]. Du G, Wei F, Li W, and Chen N, J. Eur. Ceram. Soc. 2017,37,4653–4659.
- [107]. Xu Z, Qiang H, Chen Y, and Chen Z, J. Mater. Chem. Phys. **2017**,191 ,1–5.
- [108]. Boonlakhorn J, Kidkhunthod P, Thongbai P, and Maensiri S, J. Ceram. Int. 2016,42, 8467–8472.
- [109]. Rhouma S, Saîd S, Autret C, De Almeida-Didry S, El Amrani M, and Megriche A, *J. Alloys Compd.* **2017**,717 ,121–126.
- [110]. Lee J-W, Lee G-H, Shin D-J, Kim J, Jeong S-J, and Koh J-H, J.Sci. Rep. 2018,8 ,1392.
- [111]. Kushwaha HS, Madhar NA, Ilahi B, Thomas P, Halder A, and Vaish R, Sci. Rep. 2016, 6, 18557.
- [112]. Nasr M, Balme S, Eid C, Habchi R, Miele P, and Bechelany M, J. Phys. Chem. C 2017,121,261–269.
- [113]. Nasr M, Eid C, Habchi R, Miele P, and Bechelany M, ChemSusChem 2018,11,3023-3047.
- [114]. Nasr M, Viter R, Eid C, Habchi R, Miele P, and Bechelany M, New J. Chem. 2017,41,81–89.
- [115]. Sen A and Chattopadhyay KK, J. Mater. Sci. Mater. Electron. 2016,27, 10393–10398.
- [116]. Hailili R, Wang Z-Q, Li Y, Wang Y, Sharma VK, Gong X-Q, and Wang C, *Appl. Catal. B Environ.* **2018**,221 ,422–432.
- [117]. Hailili R, Wang Z-Q, Gong X-Q, and Wang C, Appl. Catal. B Environ. 2019,254, 86–97.
- [118]. Zhu Y, Wang T, Wang W, Chen S, Lichtfouse E, Cheng C, Zhao J, Li Y, and Wang C, *Environ. Chem. Lett.* **2019**,17 ,481–486.
- [119]. Pal K, Mondal A, Jana R, Ray PP, and Gayen A, J.Appl. Surf. Sci. 2019,467–468,543–553.
- [120]. Coey JMD, J. Alloys Compd. **2001**,326 ,2–6.
- [121]. Mandal P, Pitcher MJ, Alaria J, Niu H, Borisov P, Stamenov P, Claridge JB, and Rosseinsky MJ, *Nature* **2015**,525 ,363.
- [122]. Leslie-Pelecky DL and Rieke RD, J. Chem. Mater. 1996,8,1770–1783.
- [123]. Koitzsch A, Blumberg G, Gozar A, Dennis B, Ramirez AP, Trebst S, and Wakimoto S, *J.Phys. Rev. B* **2002**,65,52406.

- [124]. Pansara PR, Raval PY, Vasoya NH, Dolia SN, and Modi KB, *J.Phys. Chem. Chem. Phys.* **2018**,20 ,1914–1922.
- [125]. Raval PY, Pansara PR, Makadiya AR, Vasoya NH, Dolia SN, and Modi KB, *J. Ceram. Int.* **2018**,44 ,17667–17674.
- [126]. Gavrilova TP, Deeva JA, Yatsyk IV, Yagfarova AR, Gilmutdinov IF, Lyadov NM, Milovich FO, Chupakhina TI, and Eremina RM, *J.Phys. B Condens. Matter* **2018**,536 ,303–309.